



NAGOYA UNIVERSITY



素粒子宇宙起源研究機構

# NEWS project

Hunting of directional dark matter with emulsions  
~ Detector Technology ~

Fundamental Particle Physics Laboratory  
Graduate School of Science of Nagoya University  
Division of Particle and Astrophysical Sciences

**Tatsuhiro Naka**

**Nagoya University**

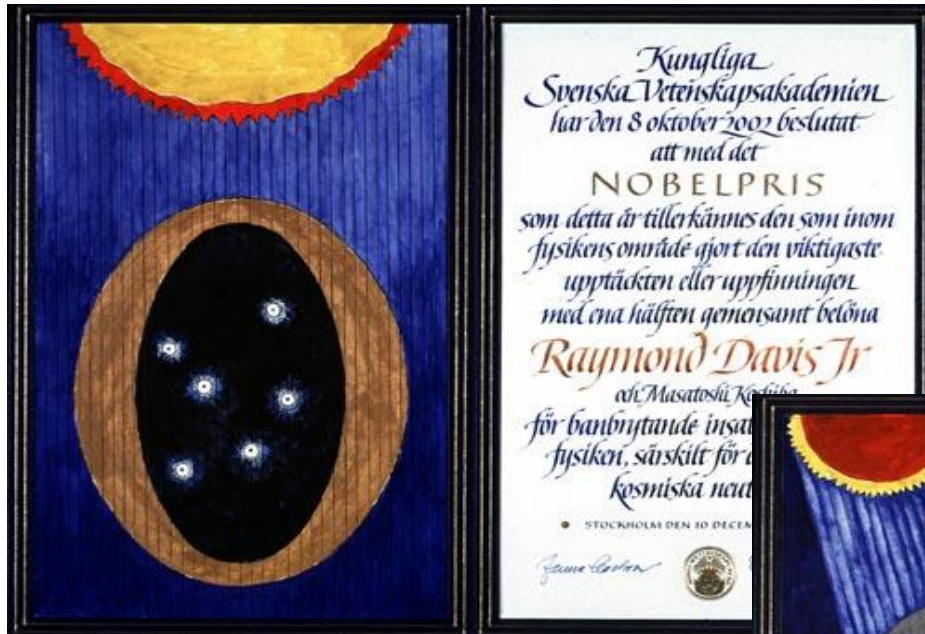
**Kobayashi-Maskawa Institute, Japan**

**on behalf of the NEWS collaboration**

NEWS seminar, 16 June, 2015@ University of Roma

# Why is directionality?

## A certificate of merit of Nobel Prize in 2002



Prof. R. Davis Jr



Current DM search motivation

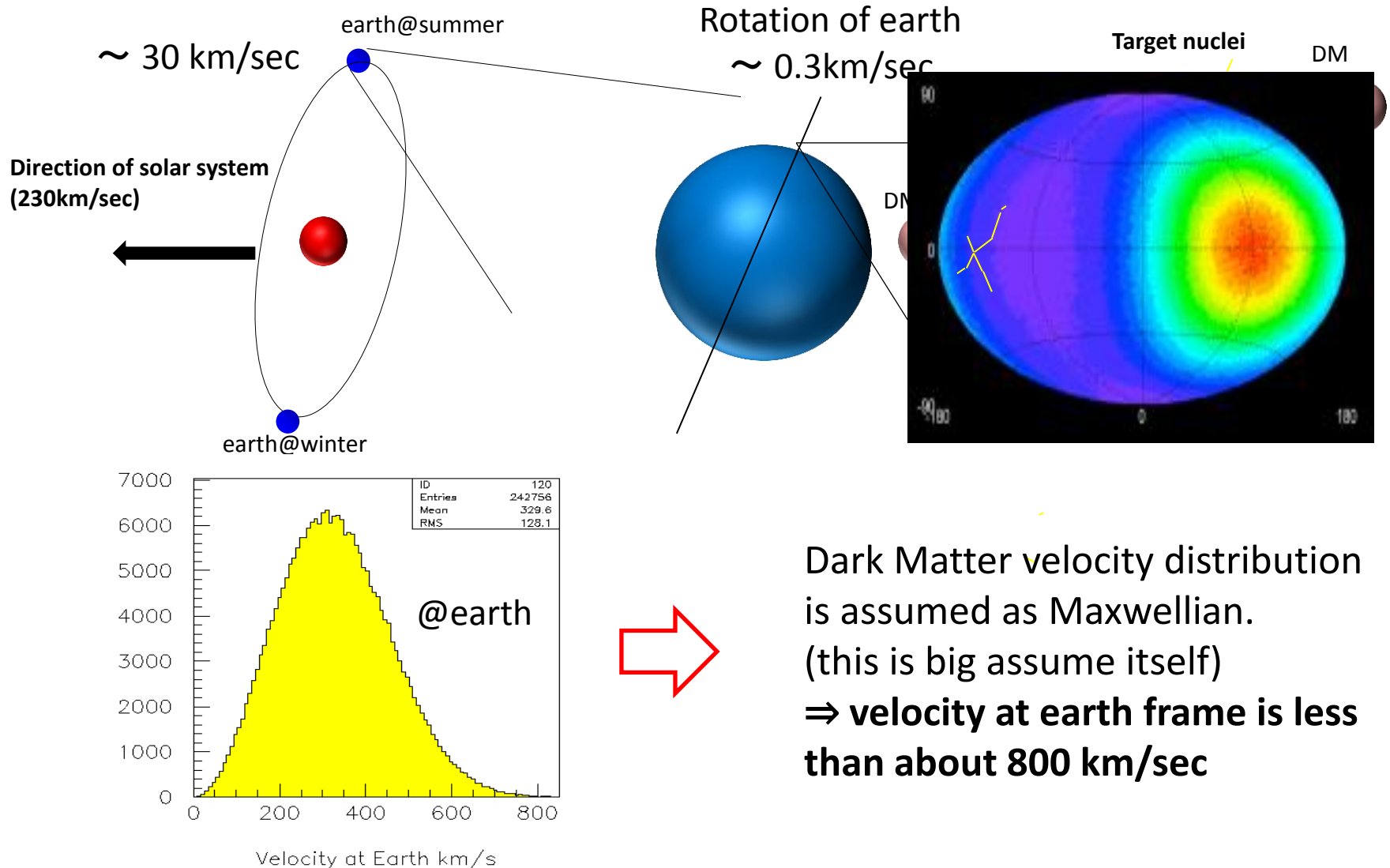
Our motivation



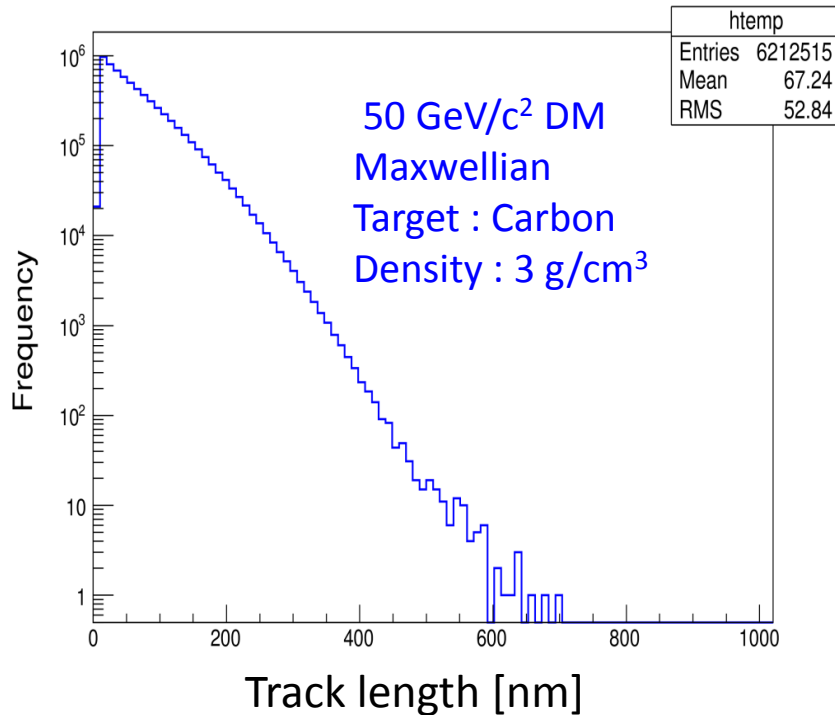
Prof. M. Koshiiba



# Directional Dark Matter Search

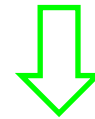


# Directional Dark Matter Search with Nuclear Emulsion



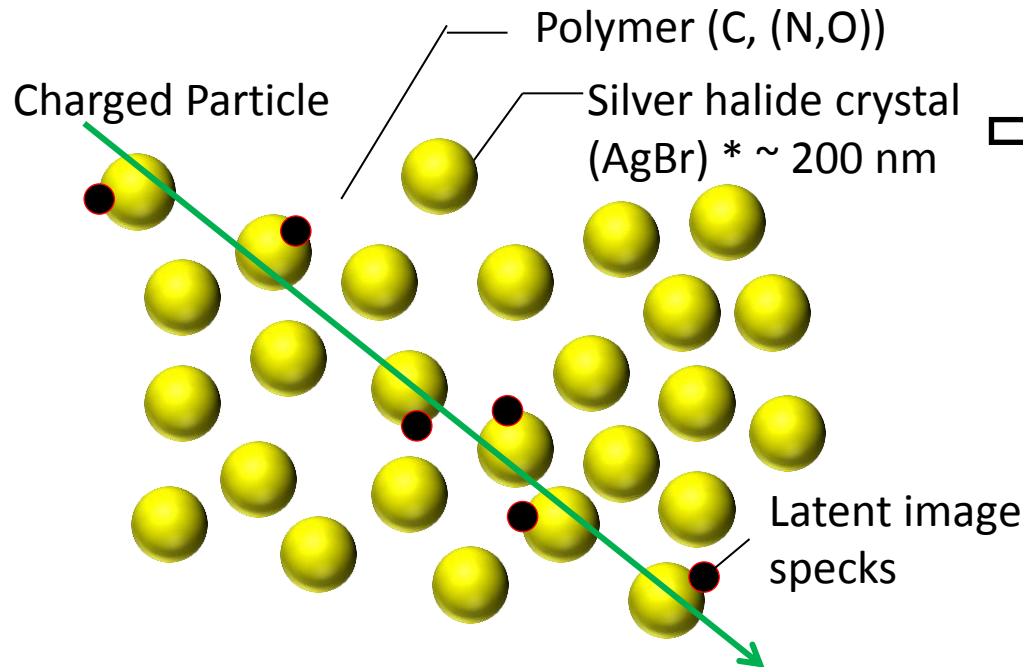
## Required Detector Performance

- High spatial resolution
- enough angular resolution
- low-background
- scalability



**Can the nuclear emulsion work as direction sensitive dark matter detector?**

# Detection Principle of emulsions detector



⇒ Semiconductor (VG ~ 2.7 eV)

□ Spatial resolution  
⇒ Crystal size and density

□ Angular Resolution  
⇒ crystal size

For example, in the case of usual type,

Crystal size : 200 nm ( $\sigma \sim 10$  nm)  
Density : 2.8 g/cm<sup>3</sup>  
(Vol. occupancy of crystal : 30 %)



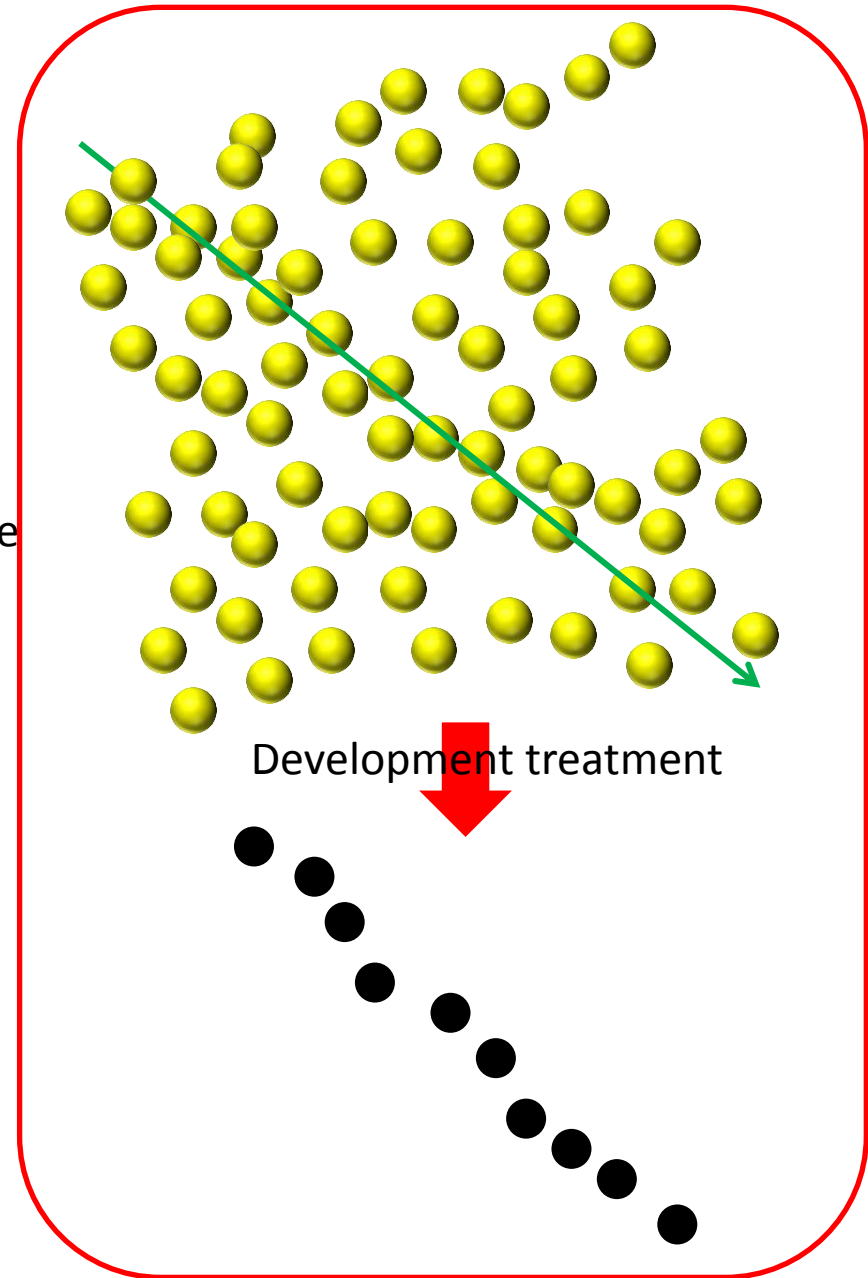
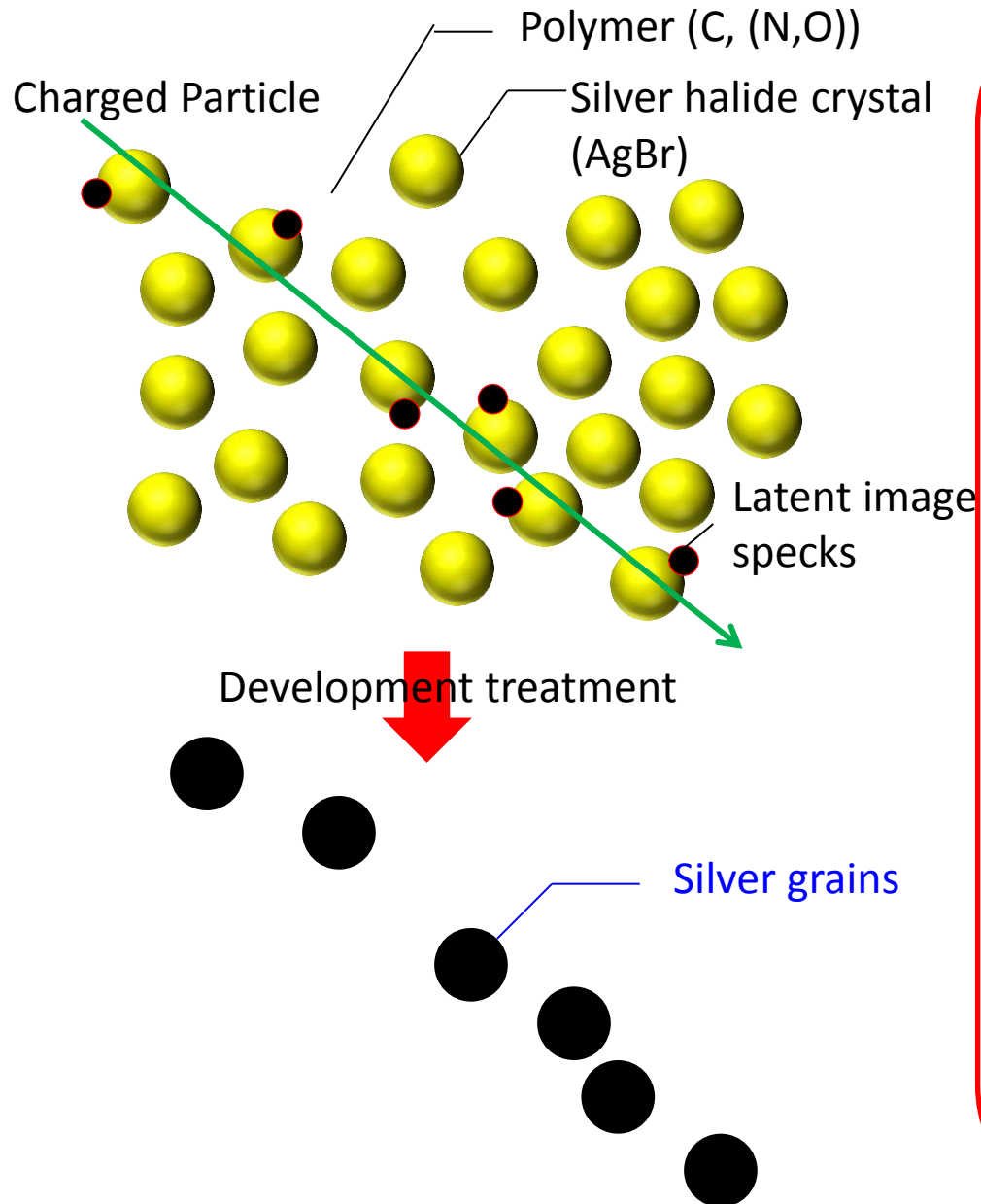
2.4 crystals /  $\mu$ m

**Detectable more than  $\mu$ m order!!**

**Resolution is poor yet for directional DM search.**



# Higher resolution



# Nuclear Emulsion Production for Dark Matter search

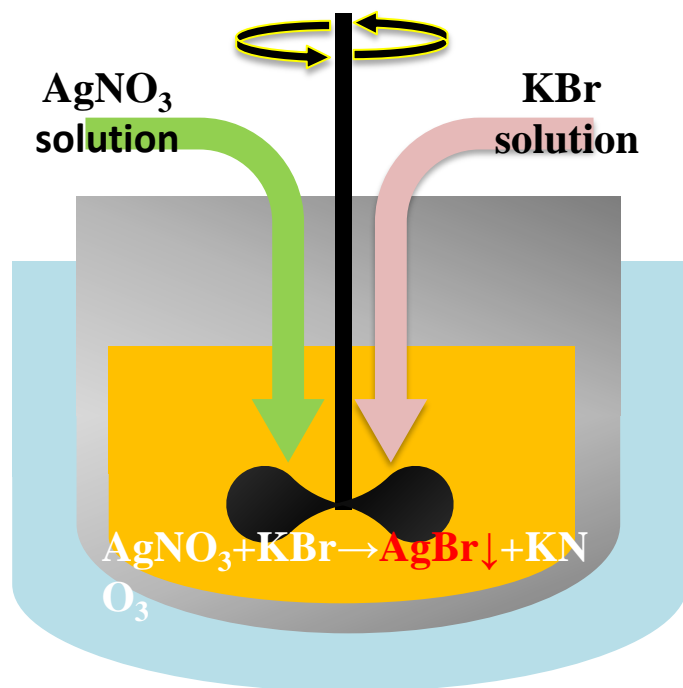


2008～ : start of discussion

2010. Apr.～ : Start of install of machine in Nagoya university

(2014～ : Install of larger scale machine )

- ❑ Development of new original device
- ❑ Elemental Study for detection mechanism
- ❑ Supply of emulsion device to the world

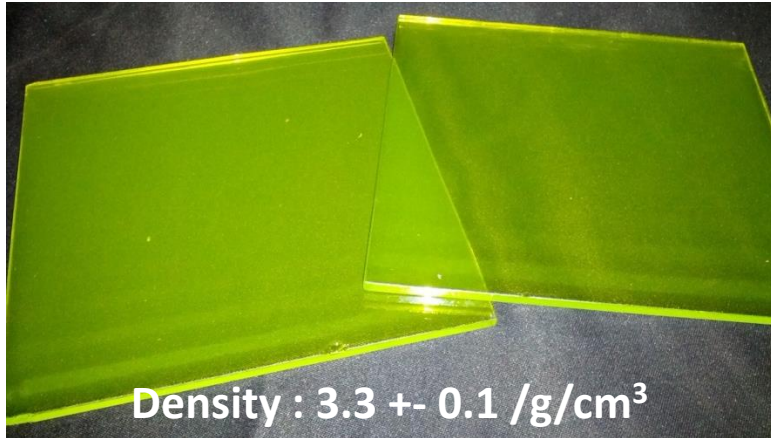


Production scale : 1 kg device/week

Production cost : 1 k EURO/device of kg  
( 60 % of all cost is AgNO<sub>3</sub> )

# Fine-Grained Emulsion

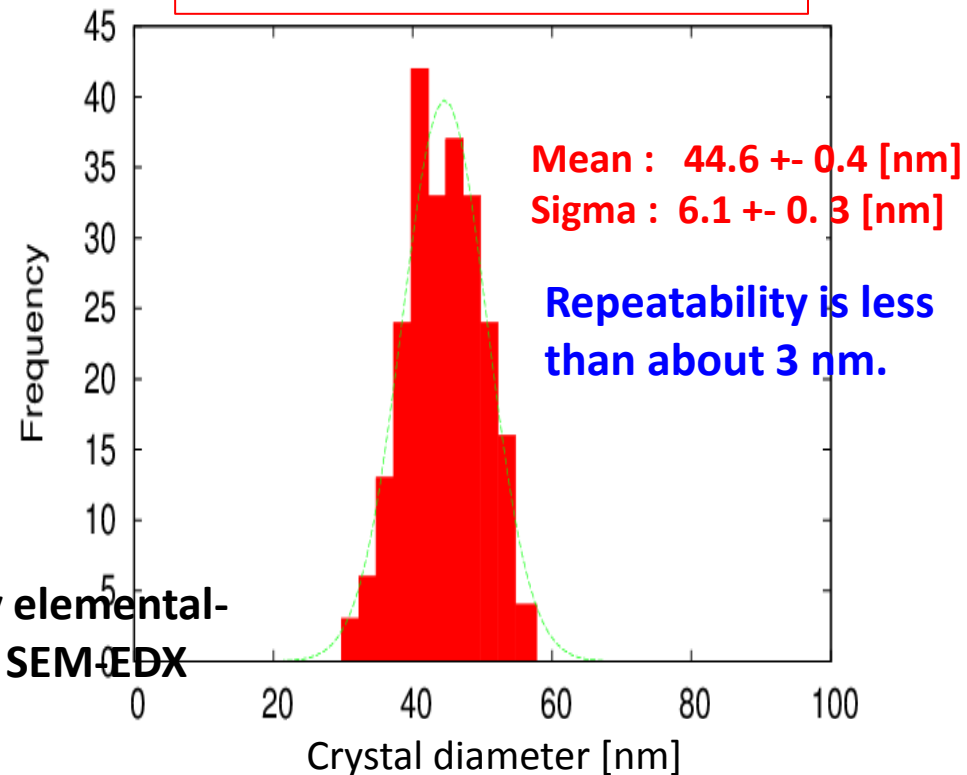
## [ Nano Imaging Traker : NIT ]



	Weight occupancy
C	10.12
H	1.63
O	7.41
N	2.68
S	0.03
Ag	44.065
Br	32.190
I	1.875

Mass fraction	
AgBr-I	0.78
Gelatin	0.17
PVA	0.05

Nano Imaging Tracker; NIT

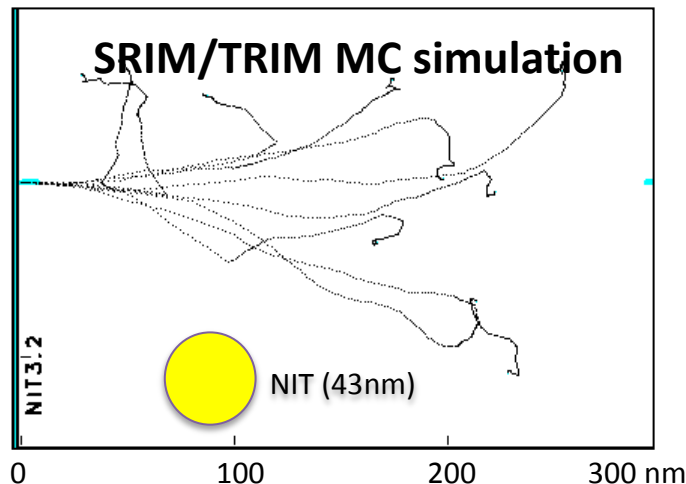
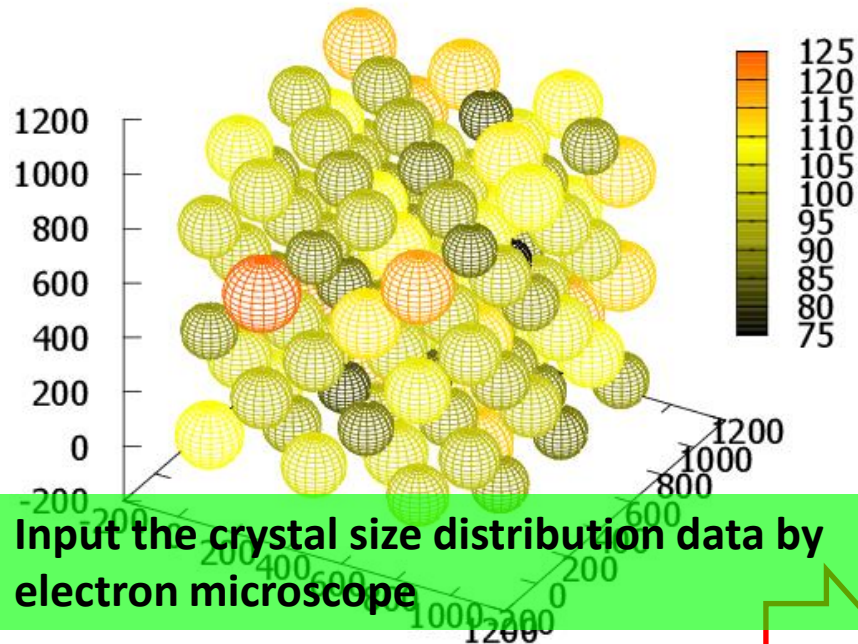


Measured by elemental-analyzer and SEM-EDX

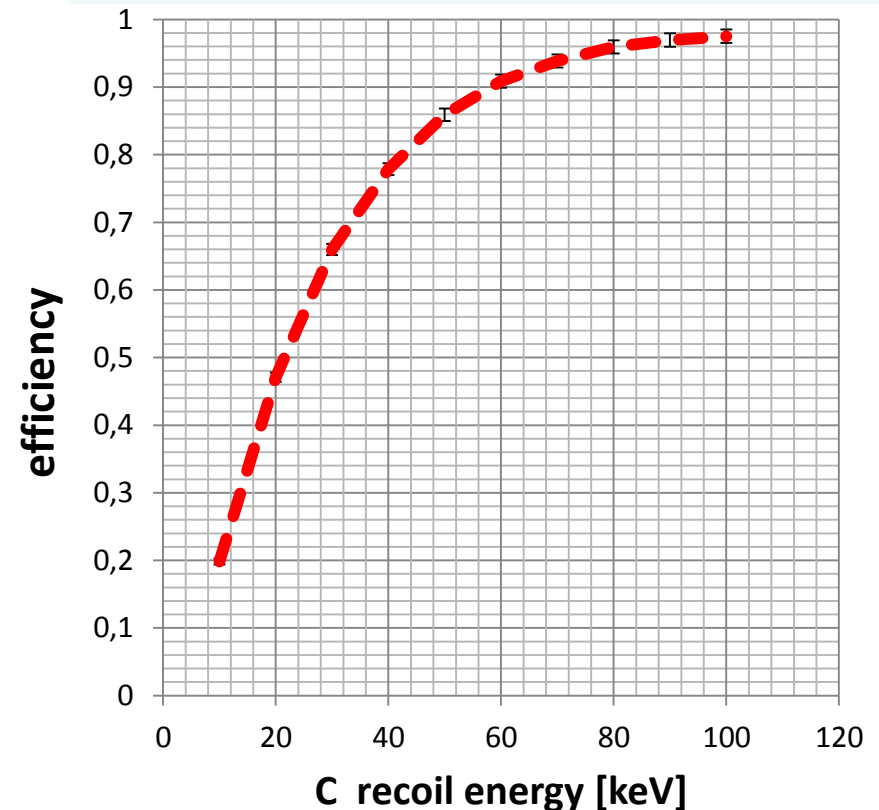


# New simulation for nuclear emulsion

## [ Intrinsic resolution with direction sensitivity]



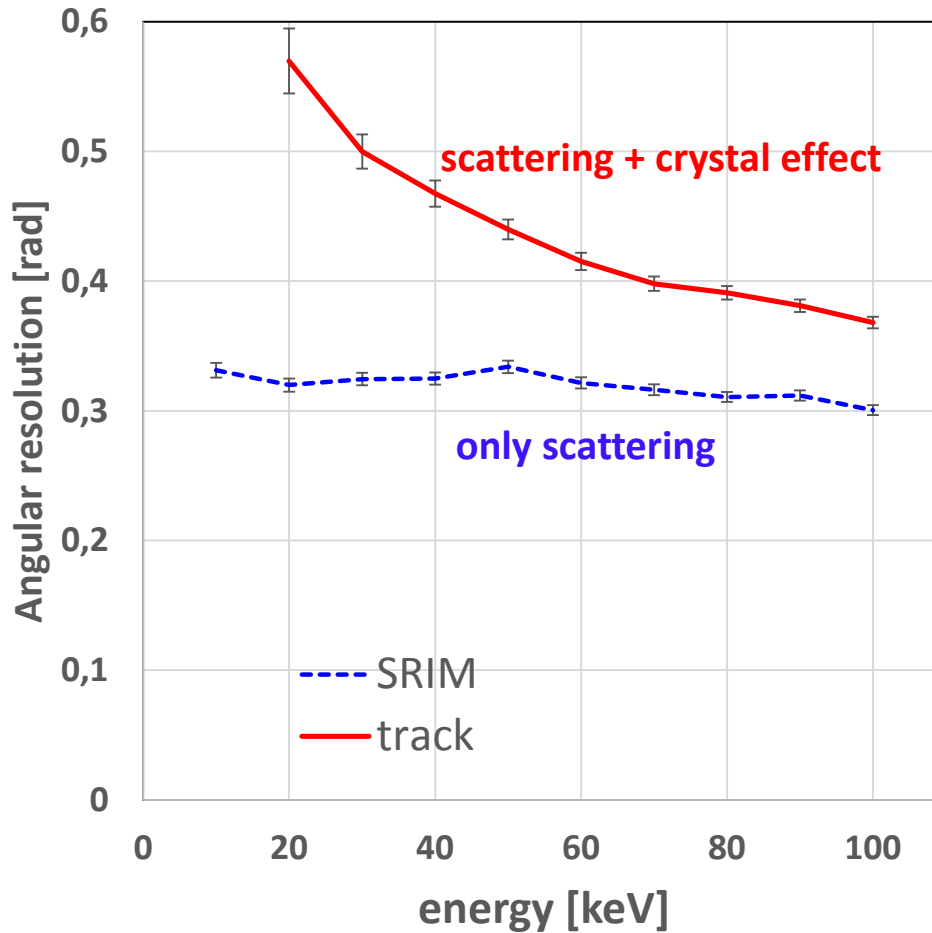
Simulated direction sensitive efficiency



**NIT has the potential of direction sensitivity to 10 keV for C recoil.**

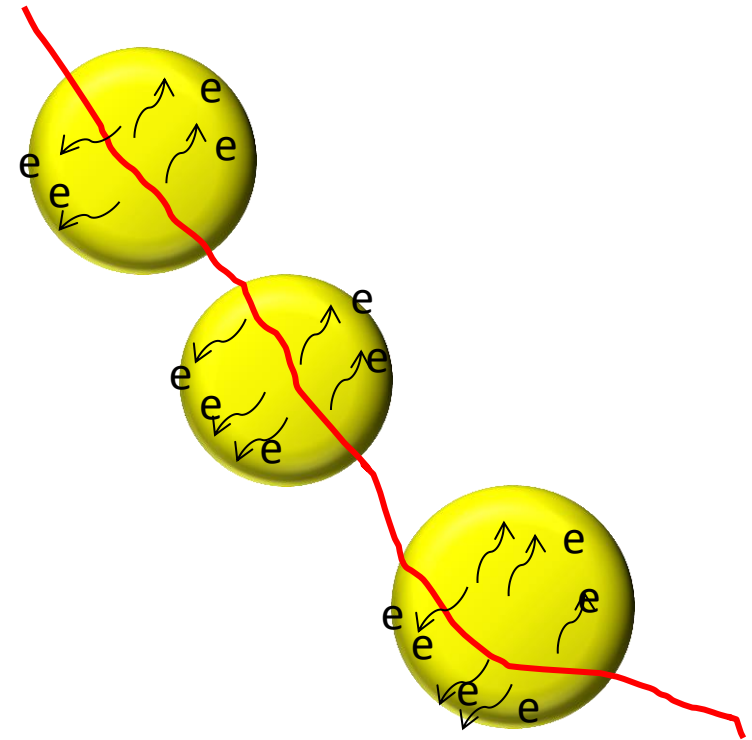
# Potential of NIT

## [ Angular resolution ]



Scattering effect : ~ 300 mrad.

Intrinsic resolution : ~ 250 mrad (crystal size effect)

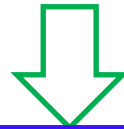


**Ionized electrons are closed in the crystal.**

**⇒ angular resolution is defined by scattering and crystal size effect**

# Readout Strategy

High-speed roughly Selection and screening  
⇒ optical microscopy



High precision analysis

Various new technology will be innovated

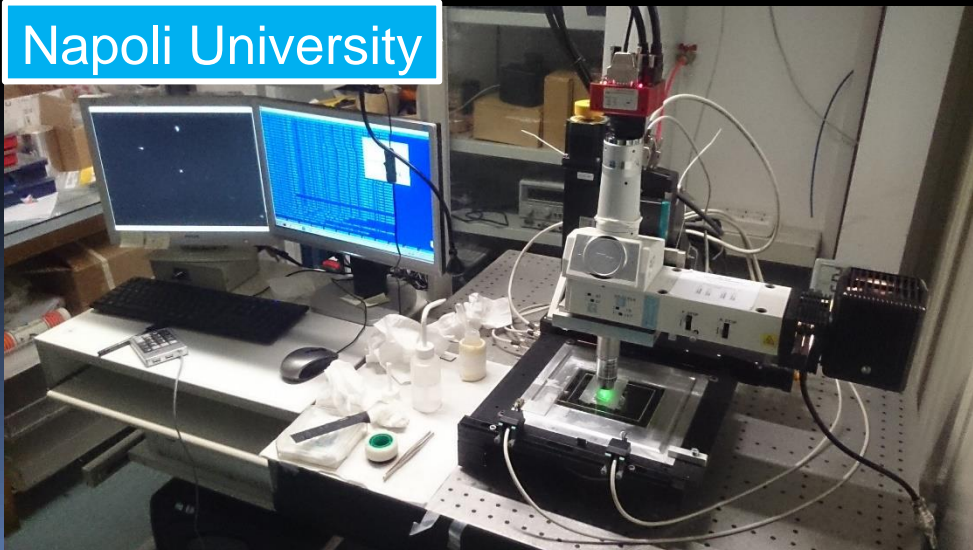
- Higher resolution microscopy
- nano-scale information
- 3D angle information
- etc.

# Optical Readout Machine for shorter length tracks

Nagoya University



Napoli University



LNGS(Gran sasso)

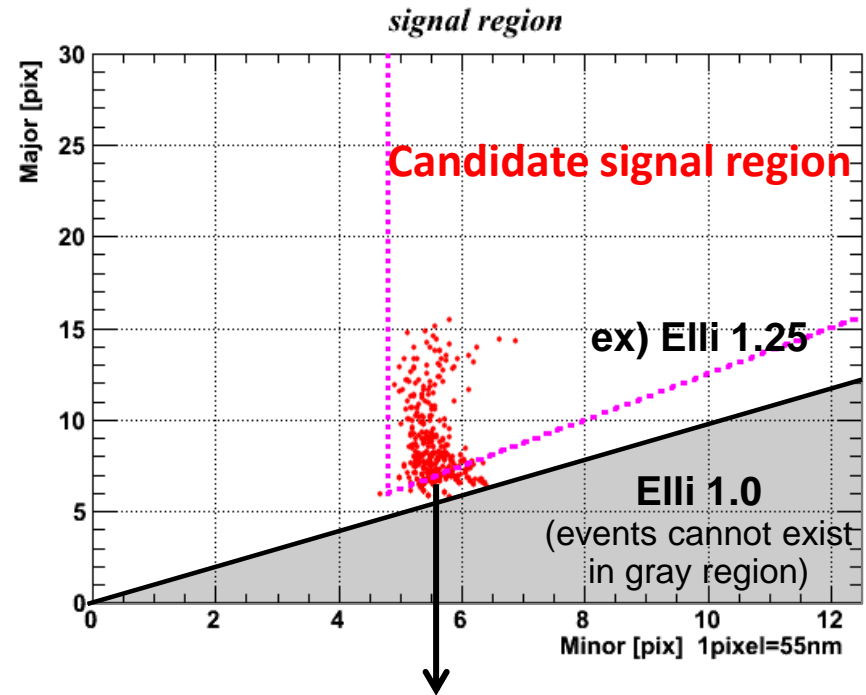
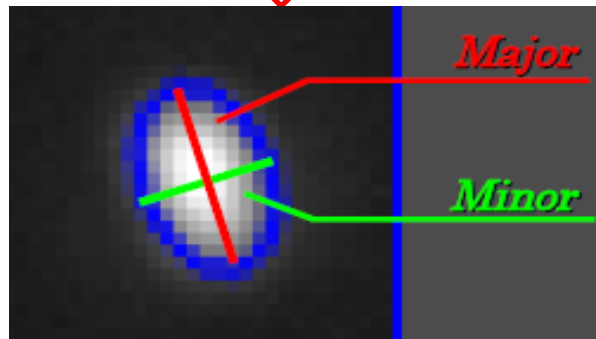
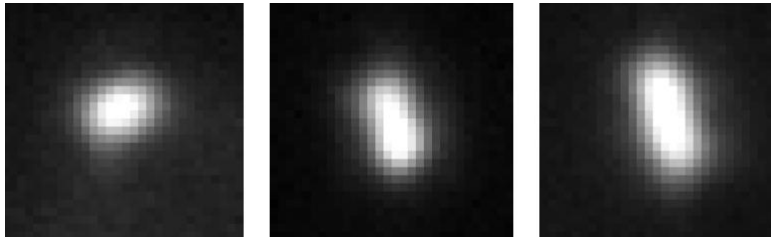


All systems are adopted the epi-illuminated optics.

# Candidate selection for optical microscope system

## Example of nuclear recoil signal

2D\_Track length vs. Ellipticity



Current selection is used the simple elliptical shape

$\gamma/\beta$  events are expected to be distributed around Ellipticity of one.

Another out put parameter

- position information
- brightness
- area of signals



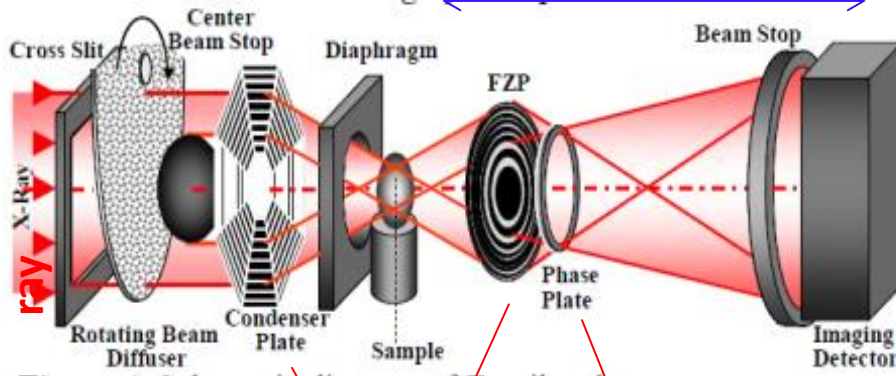
# Hard X-ray microscope



SPring-8 @ Japan



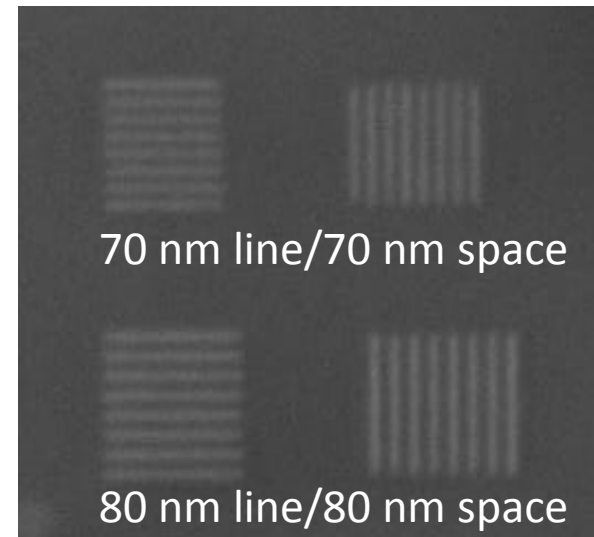
30 m



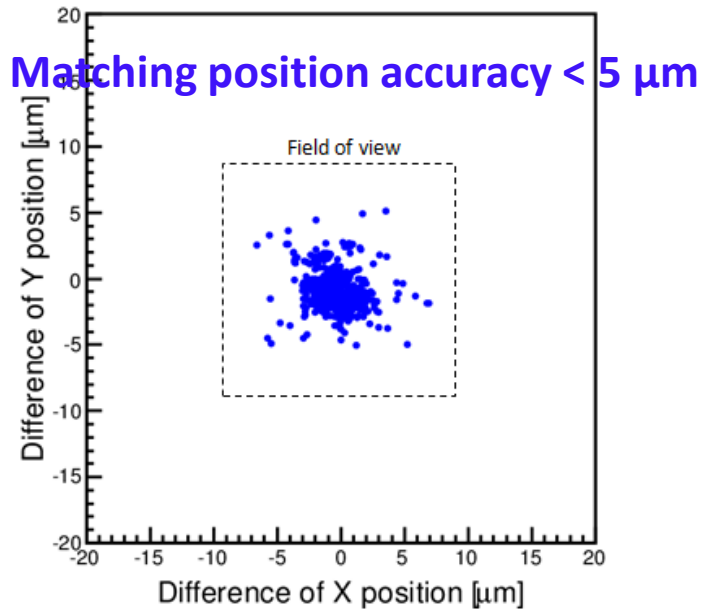
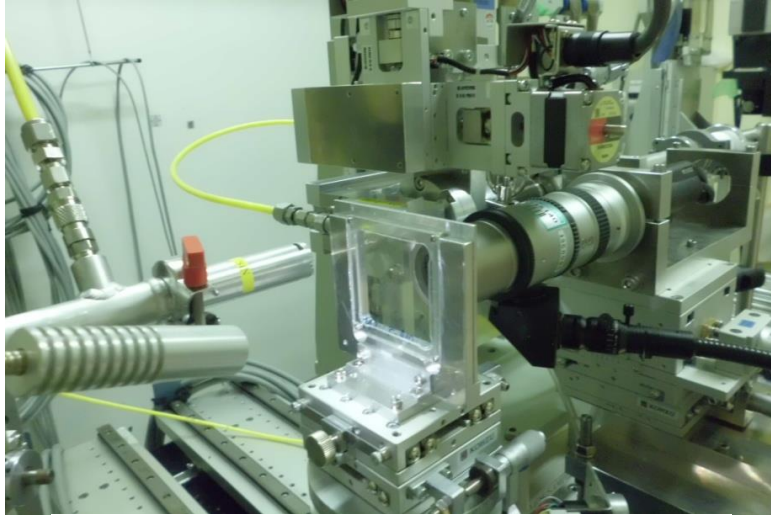
8 or 6 keV X-ray

Zone plate Zernike phase plate  
(outer most zone width of 50 nm)

Ta 100 nm thickness pertarn  
on SiN membrane (2 $\mu$ m)



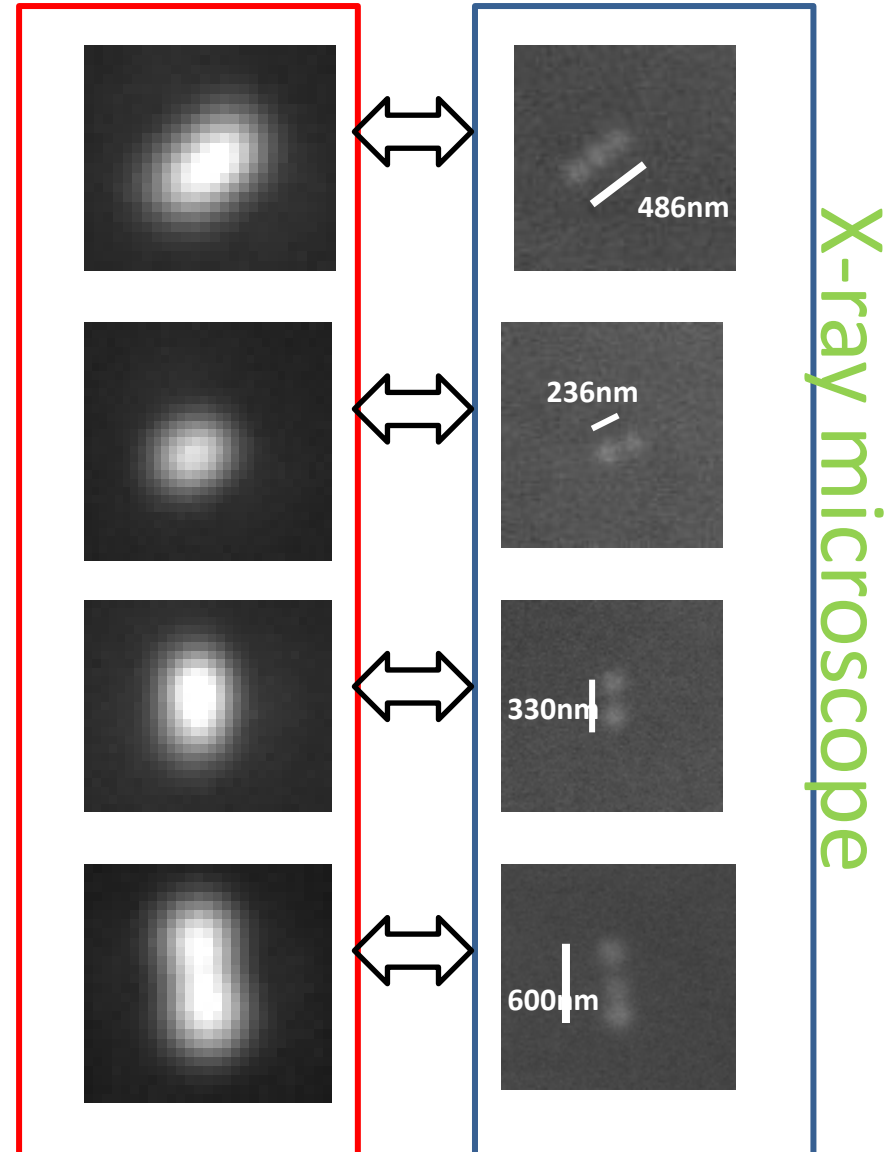
# Maching of recoiled tracks between Optical and X-ray microscope



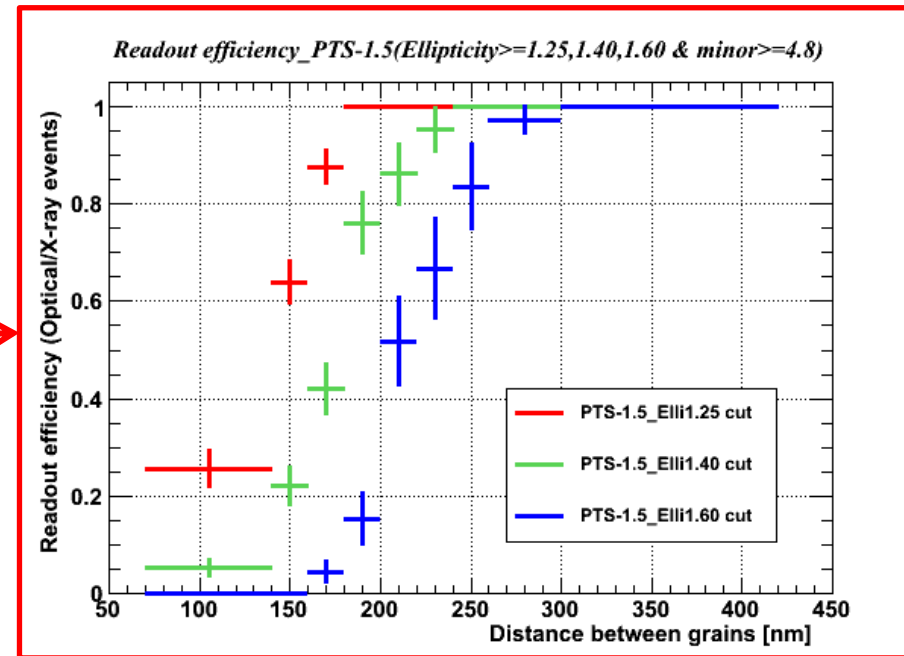
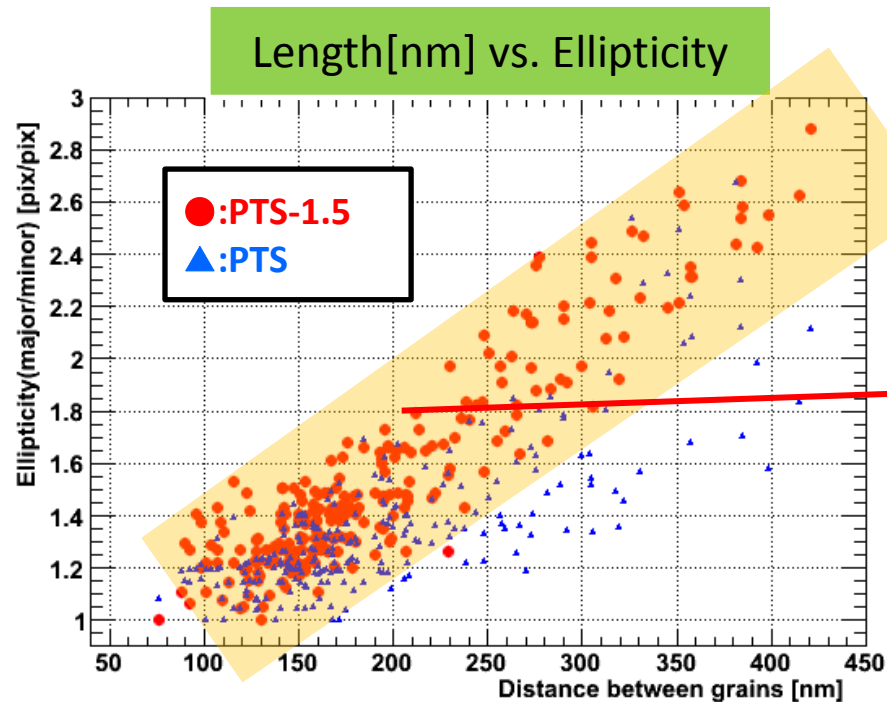
Maching efficnecy  $> 99 \%$

Imaging speed : 1000 events /days

Optical microscope



# Readout Efficiency dependence of ellipticity to real length



	PTS-1	PTS-1.5
N.A. of obj. lens	1.25	1.4
Wavelength	550 nm	450 nm
Optical resolution [ measurement from PSF]	315 nm	233 nm

By high resolution setup,  
we can read out more than  
100 nm length tracks.

# Tracking Study

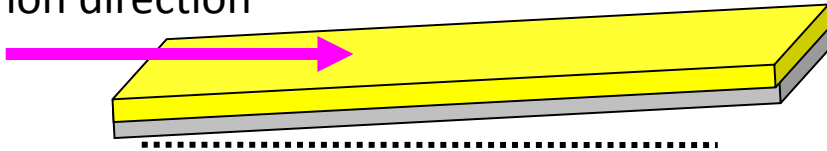
## [ Ion-implantation ]



Type of gas :  $\text{CO}_2$  • Ar, Kr  
Dose Intensity :  $> 1\text{E}+7$  / $\text{cm}^2$   
Accelerate Voltage : 10 -200 keV  
( Higher energies can be exposed by control of ionic valence. )  
Ex.  $200 \text{ kV} \times \text{Kr}^{2+} = 400 \text{ keV Kr}$

Exposure condition  
Vacuum level :  $\sim 1\text{E}-7$  torr  
recorded area of film : surface

ion direction

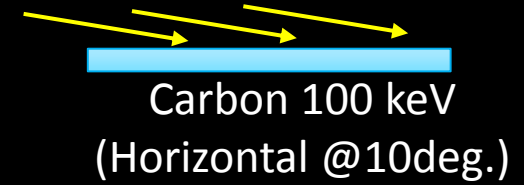
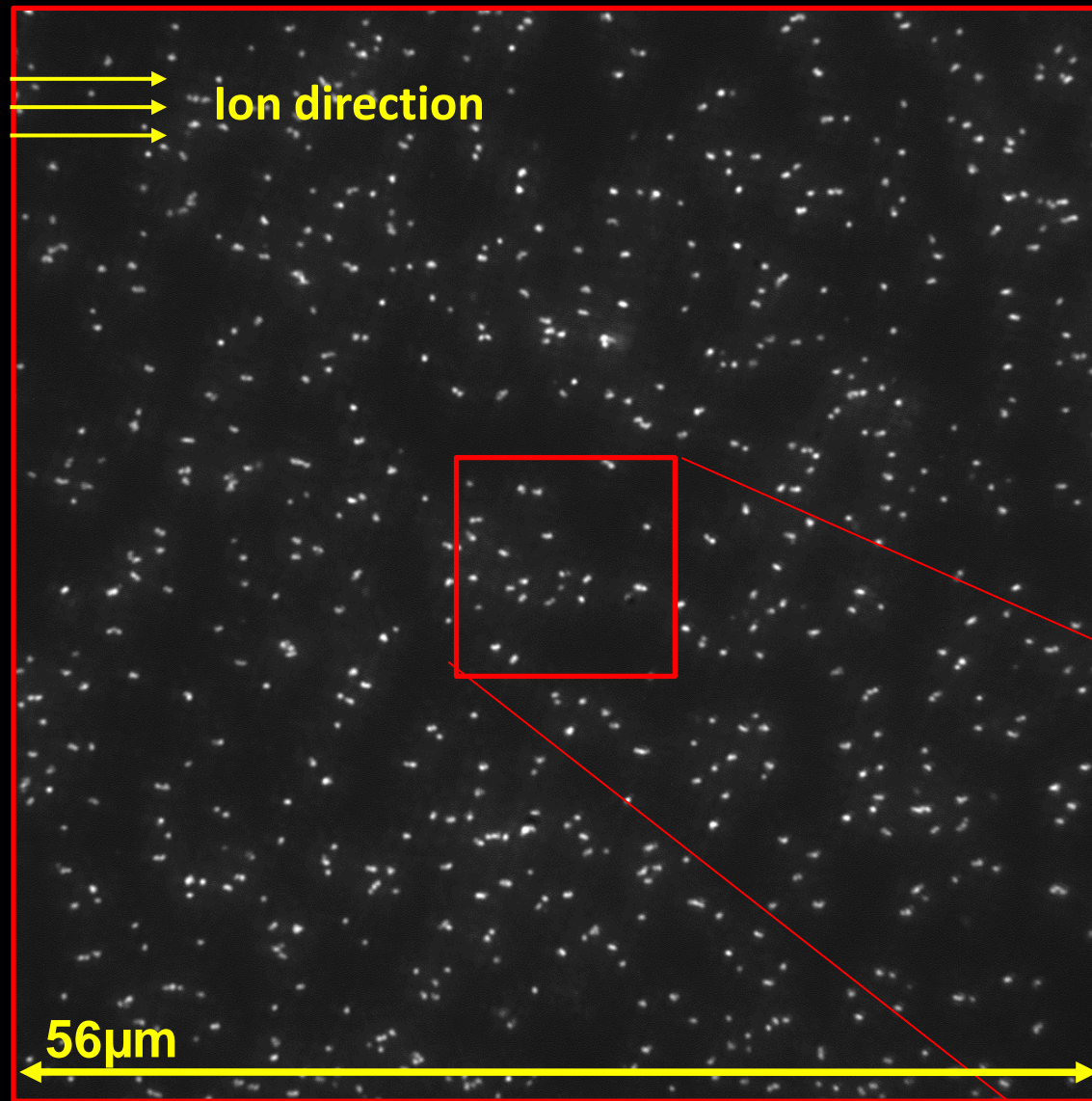


- ❑ monochromatic energy
- ❑ uniform direction (  $< 1 \text{ mrad.}$  )

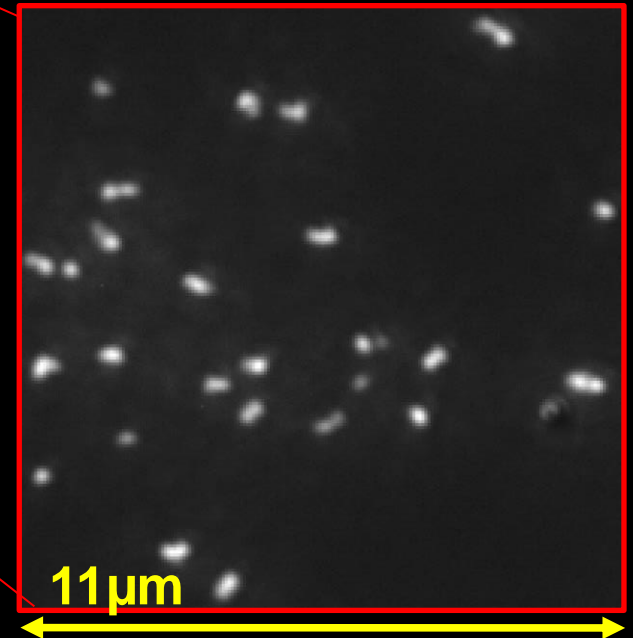
Detector performance  
⇒ [ detection efficiency, angular resolution ]



# Actual image of tracks @Carbon 100 keV



Blue

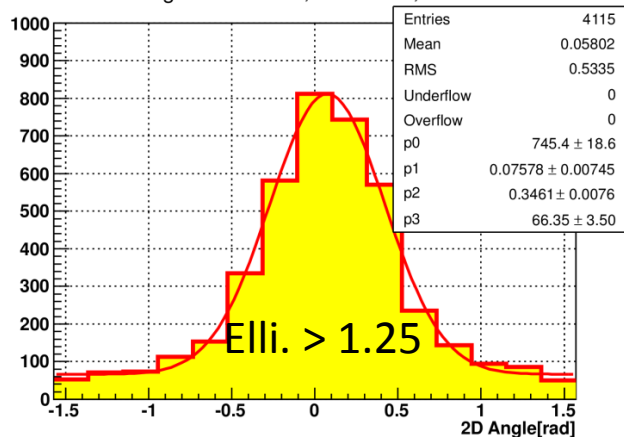




# Angular distribution measured by optical microscope

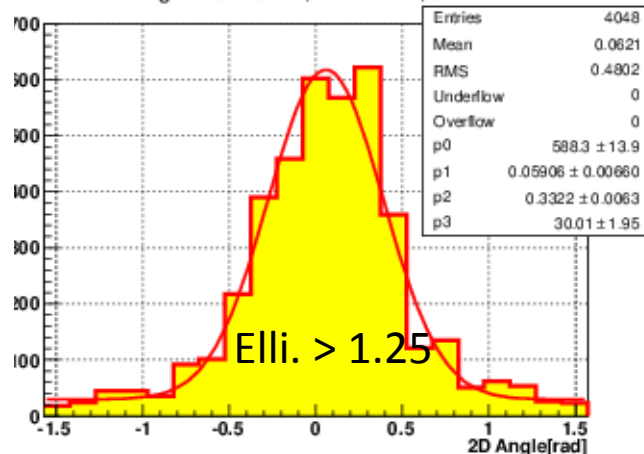
100 keV C

Angle distribution,  $E_{\text{li}} \geq 1.25$ , bin=15



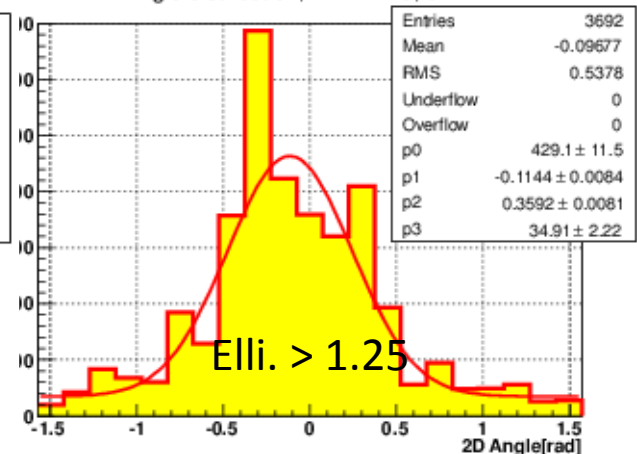
80 keV C

Angle distribution,  $E_{\text{li}} \geq 1.25$ , bin=21

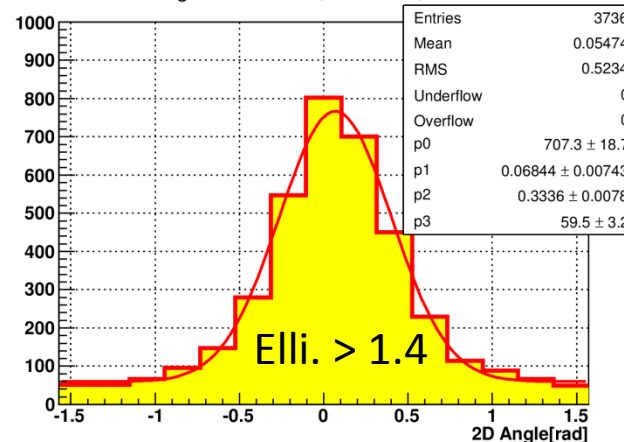


60 keV C

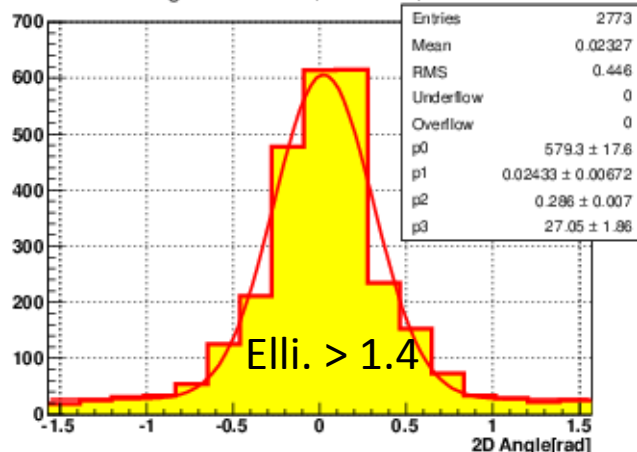
Angle distribution,  $E_{\text{li}} \geq 1.25$ , bin=21



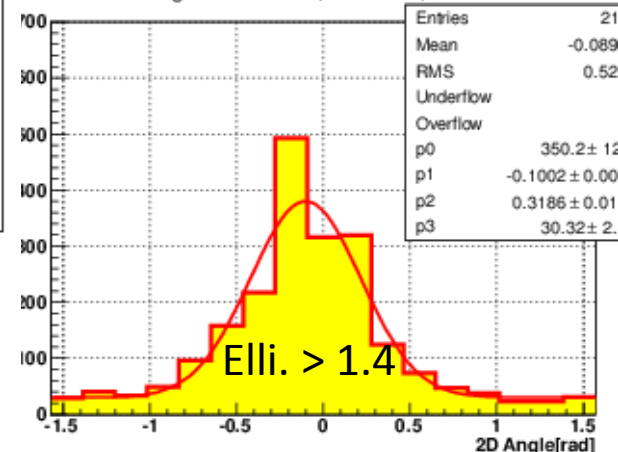
Angle distribution,  $E_{\text{li}} \geq 1.3$ , bin=15



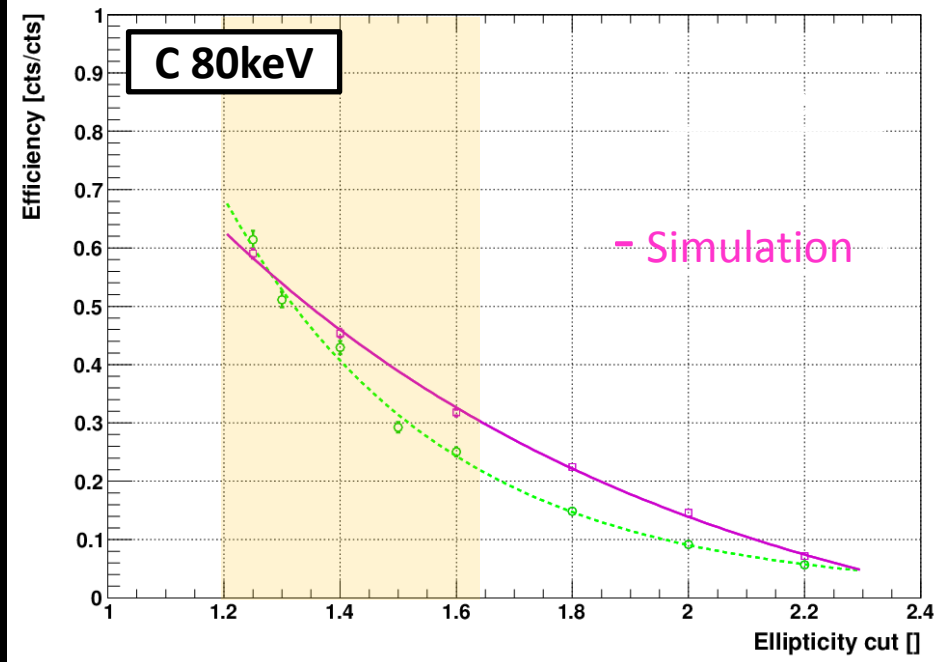
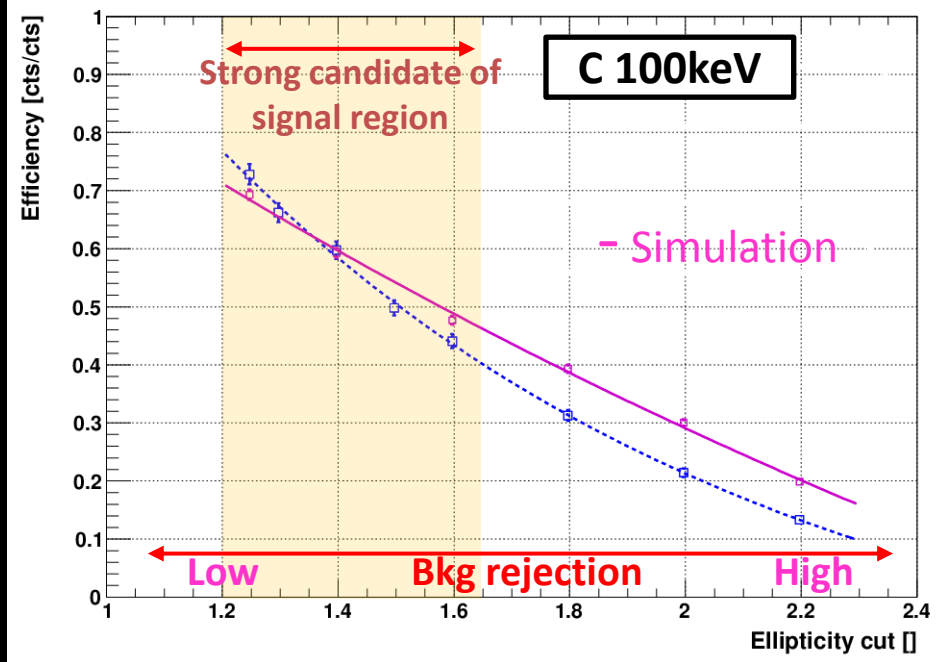
Angle distribution,  $E_{\text{li}} \geq 1.4$ , bin=17



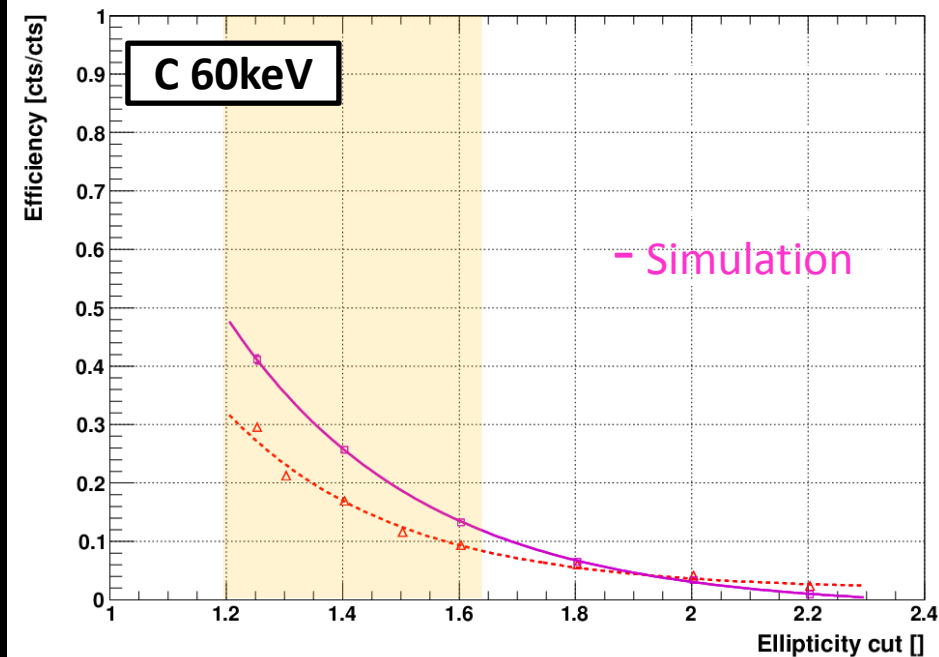
Angle distribution,  $E_{\text{li}} \geq 1.4$ , bin=17



# Detection efficiency for each signal region

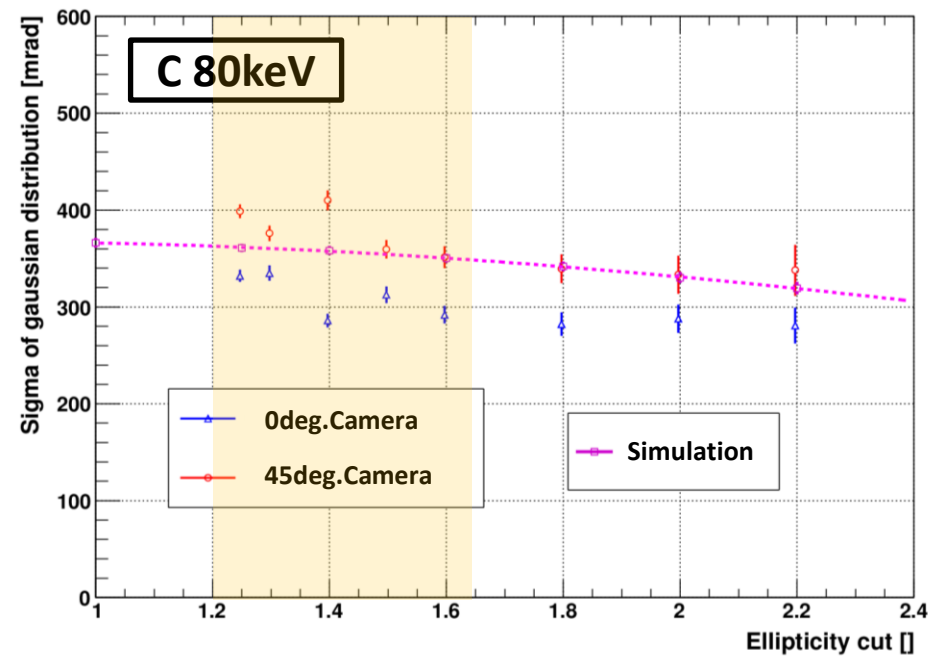
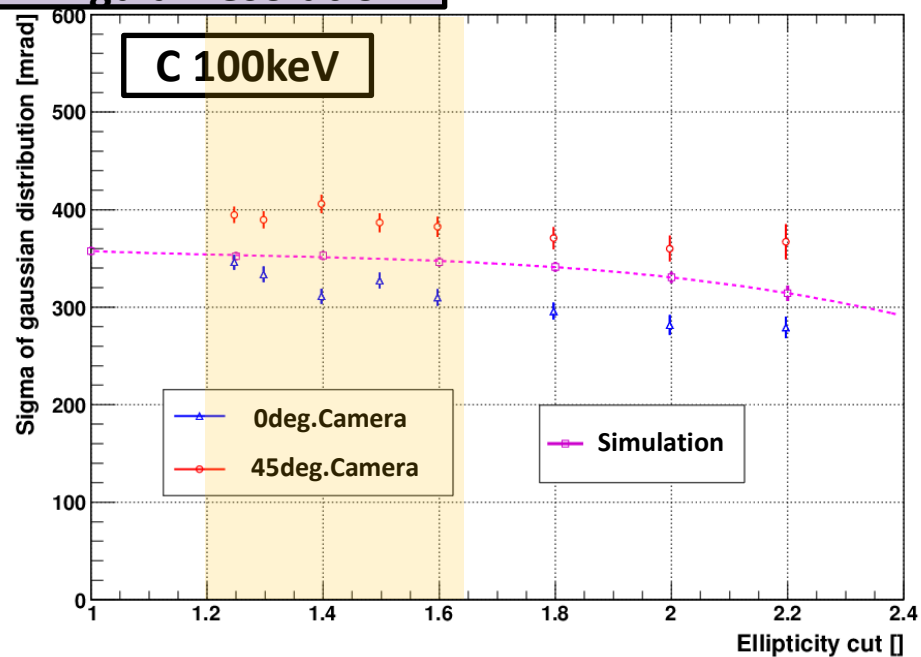


“Ellipticity cut” vs. “Efficiency”



Simulation was assumed 100 % quantum efficiency of crystal

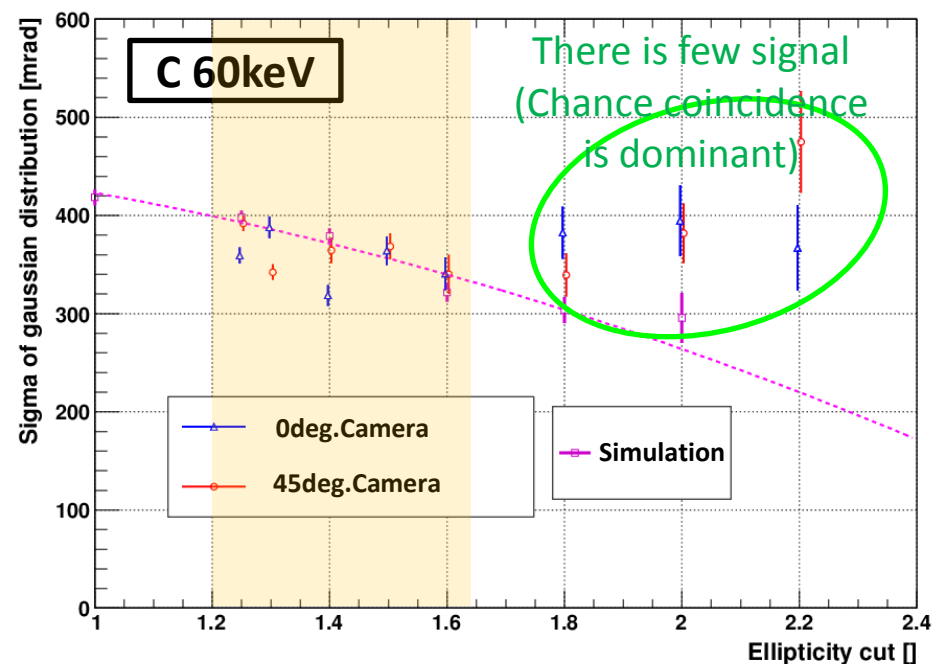
## Angular resolution



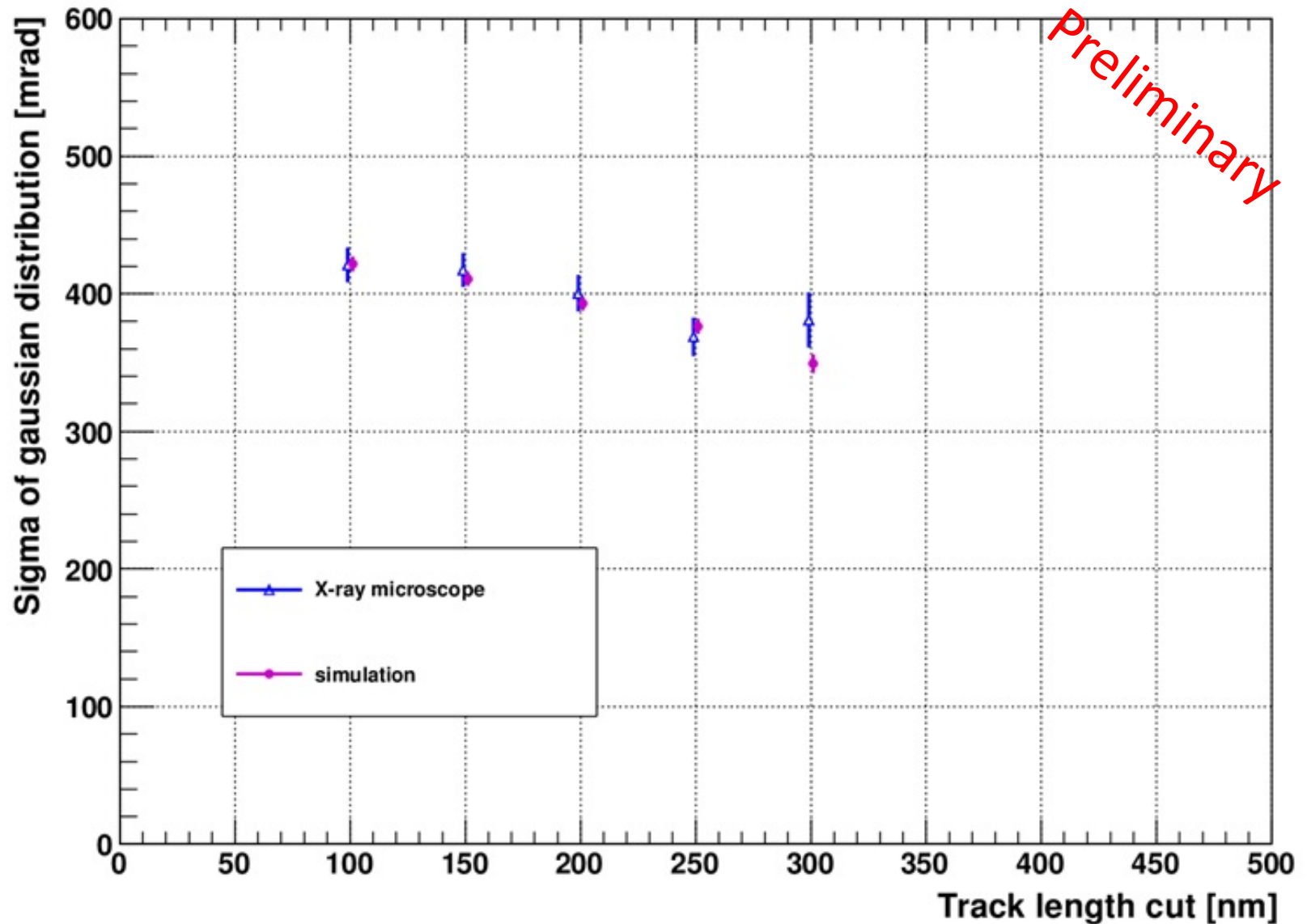
“Ellipticity cut”

VS.

“Sigma of Gaussian in angular distribution”

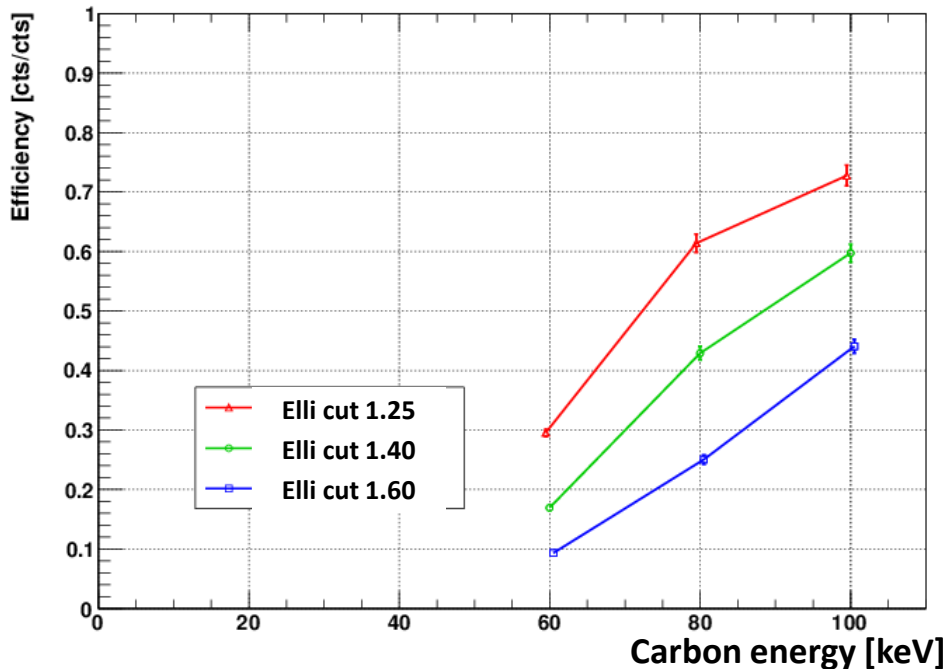


# Comparison of angular resolution between X-ray measurement and simulation

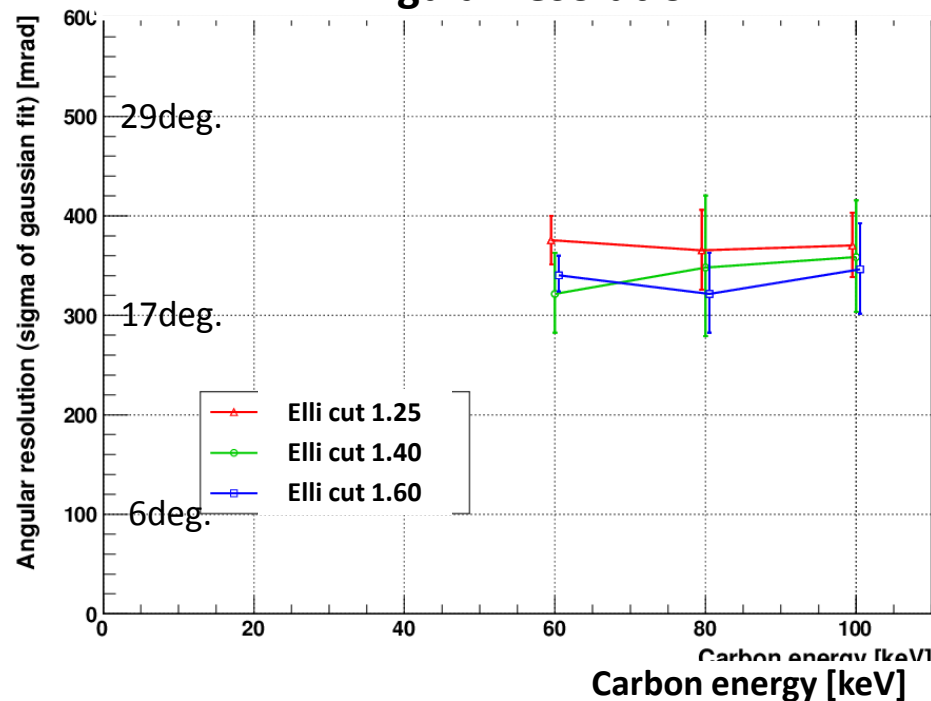


# Result of performance [ 60 – 100 keV] [ Ion-implant system]

Absolute efficiency with direction sensitivity



“Angular resolution”



Energy	Elli>1.4	Elli>1.25
100 keV	$59.7 \pm 1.5(\text{stat}) \%$	$72.8 \pm 1.7(\text{stat}) \%$
80 keV	$42.9 \pm 1.2(\text{stat}) \%$	$61.4 \pm 1.5(\text{stat}) \%$
60keV	$16.9 \pm 0.4(\text{stat}) \%$	$29.5 \pm 0.6(\text{stat}) \%$

**Angular resolution ~ 350 mrad.**

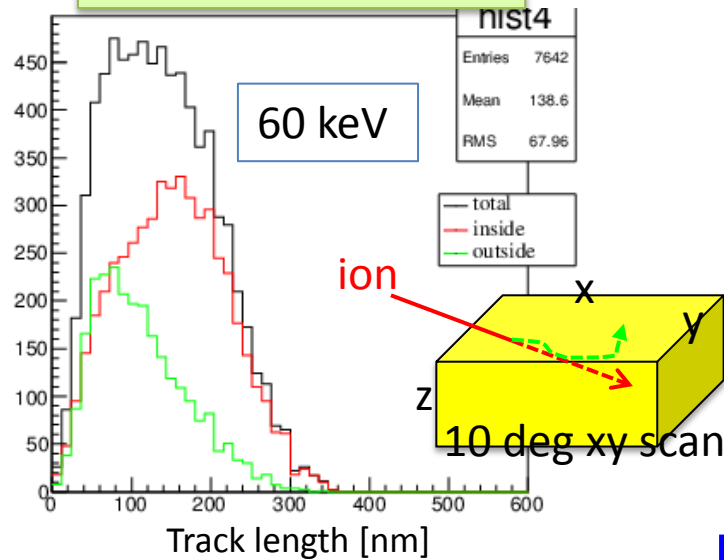
Angular resolution is top value to  
another directional DM detector.

Systematic uncertainties have several % .

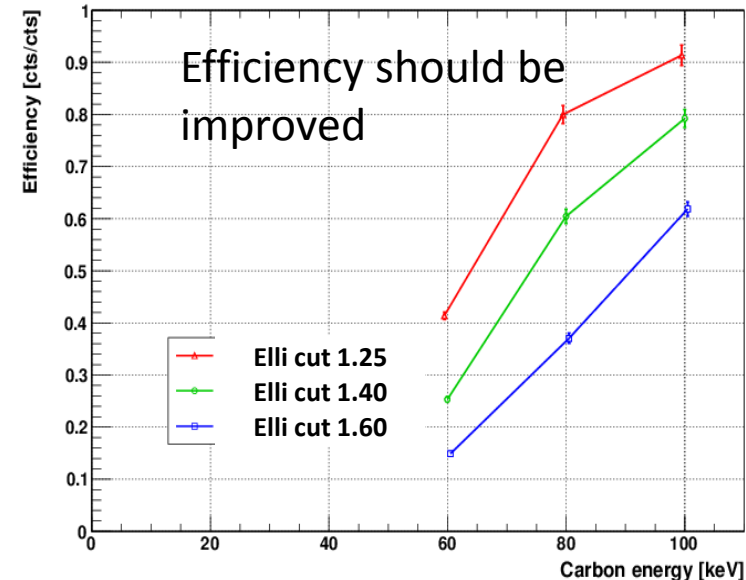
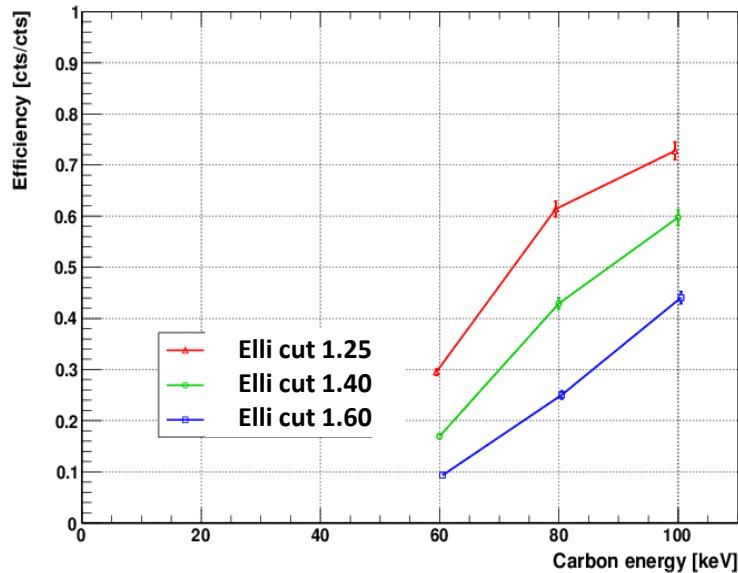
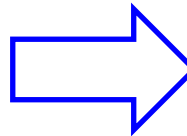
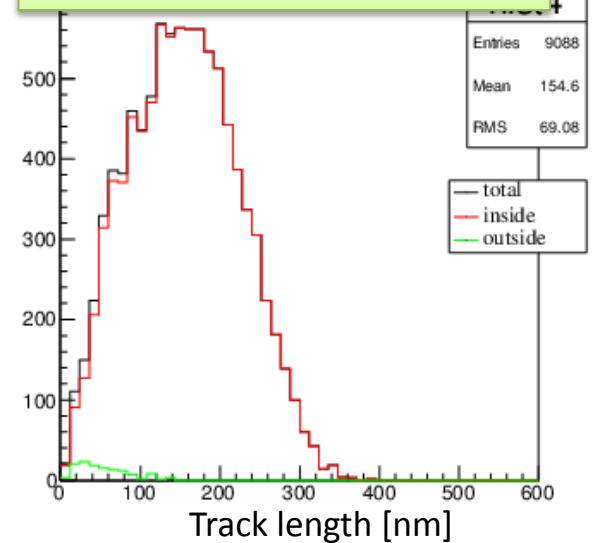


# Correction of non-fiducial region effect

ion implant situation

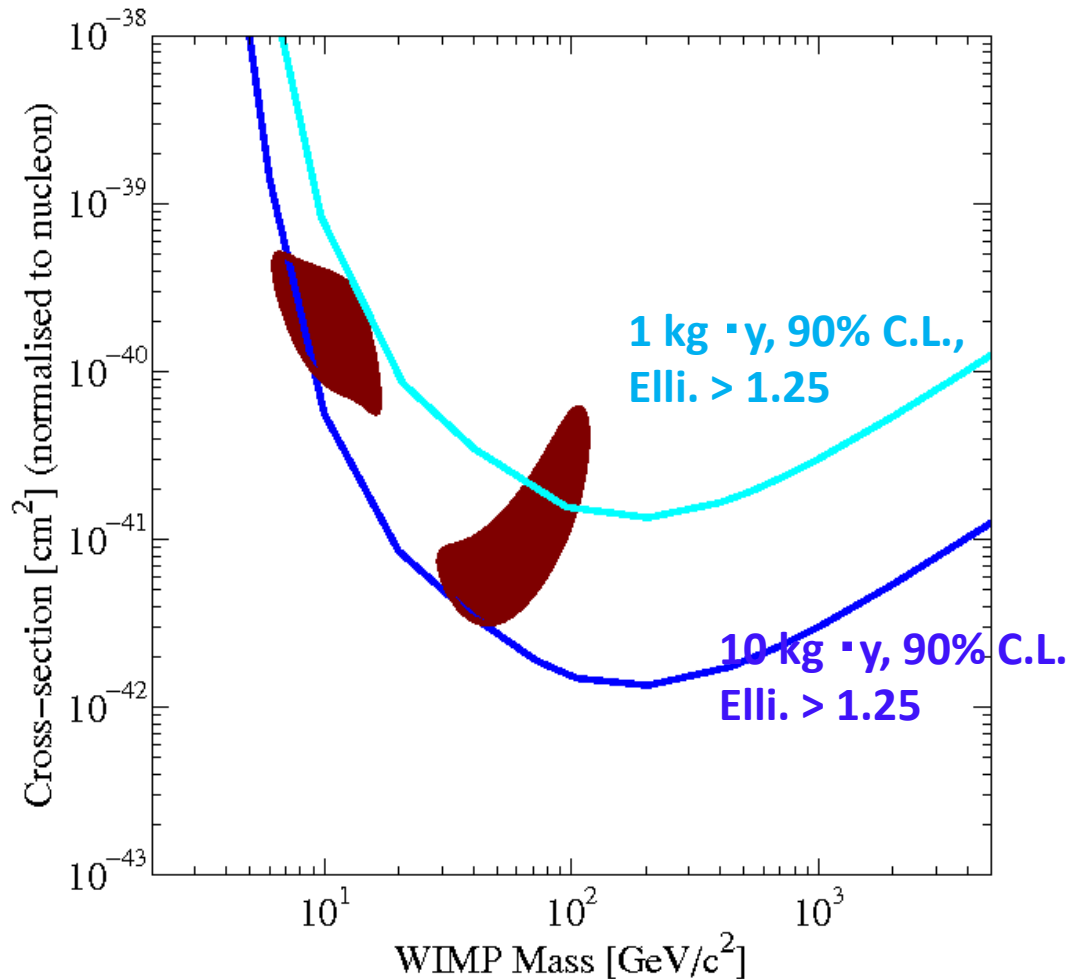


DM experiment situation



Current device was more than 40 % efficiency for 60 keV C recoil

# Updated Spin-independent cross section limit [ main target : CNO + Ag,Br]

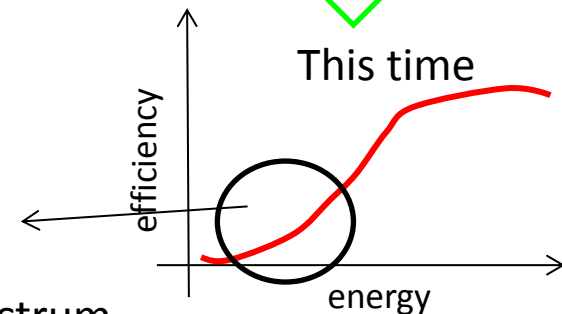
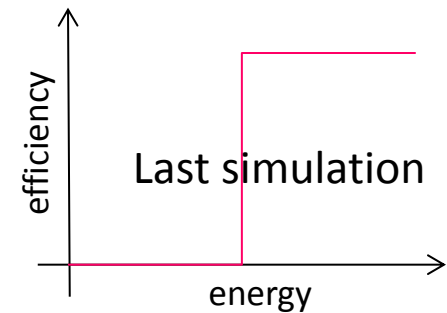


## Efficiency condition

80% eff. @ 80 keV

40 % eff. @ 60 keV

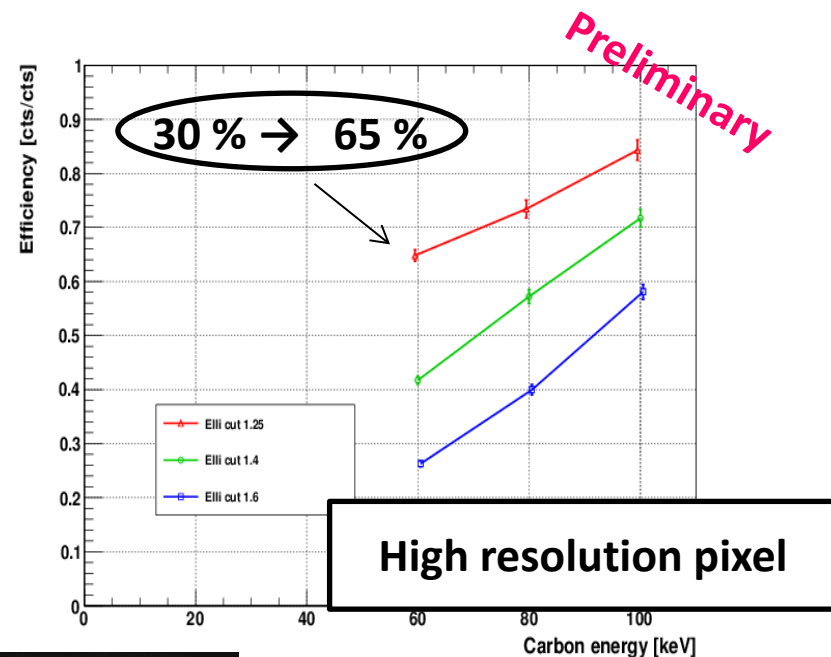
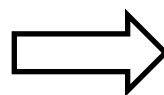
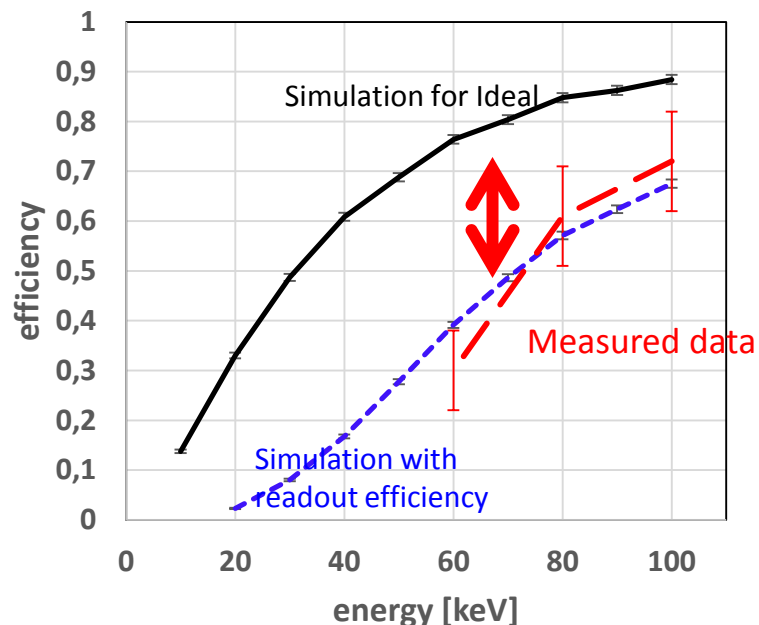
and lower energy efficiencies  
are extrapolate using fitting  
function



Non-zero efficiency is  
important because of  
exponential energy spectrum

# Further improve of efficiency

tracking detection efficiency

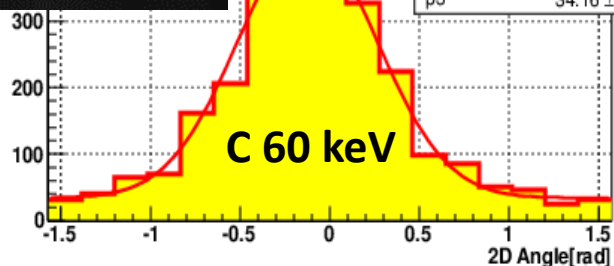


20 x 20 pix

55 nm/pix

distribution, Elli>=1.3, bin=17

Entries	2688
Mean	-0.0984
RMS	0.5451
Underflow	0
Overflow	0
p0	$389.4 \pm 12.0$
p1	$-0.1245 \pm 0.0102$
p2	$0.388 \pm 0.011$
p3	$34.16 \pm 2.64$

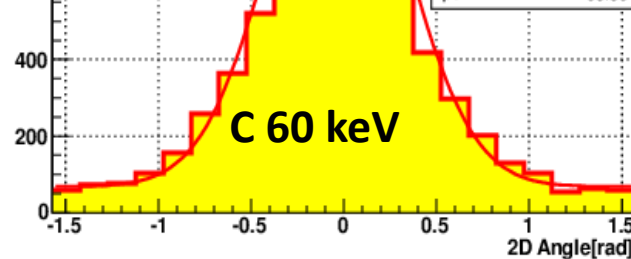


40 x 40 pix

22.5 nm/pix

distribution, Elli>=1.3, bin=21

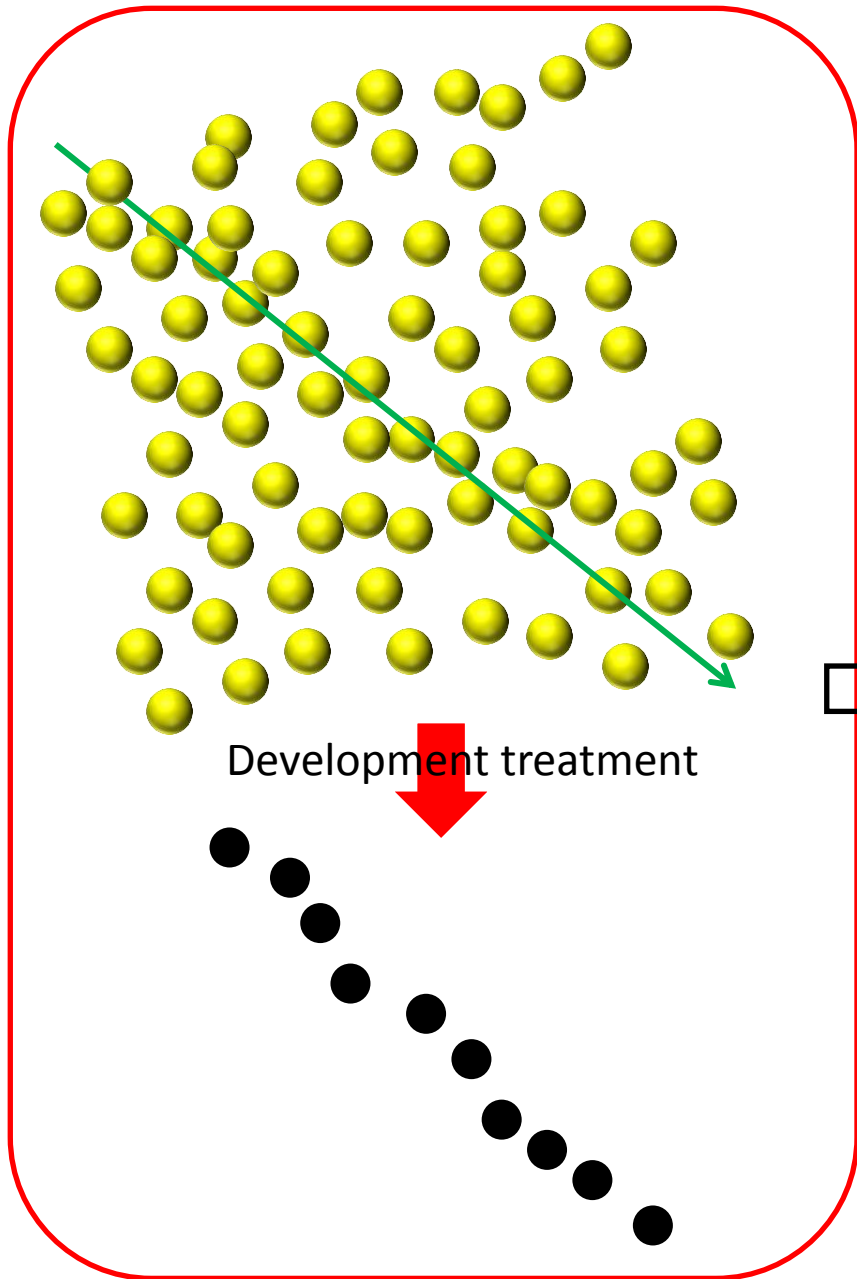
Entries	7699
Mean	-0.03124
RMS	0.5096
Underflow	0
Overflow	0
p0	$1007 \pm 18.2$
p1	$-0.03499 \pm 0.00539$
p2	$0.3665 \pm 0.0061$
p3	$68.36 \pm 3.23$



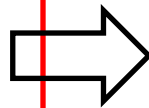
# Another high precision analysis and lower background study

- ❑ Background discrimination
- ❑ signal confirmation
- ❑ lower background

Higher resolution



Development treatment

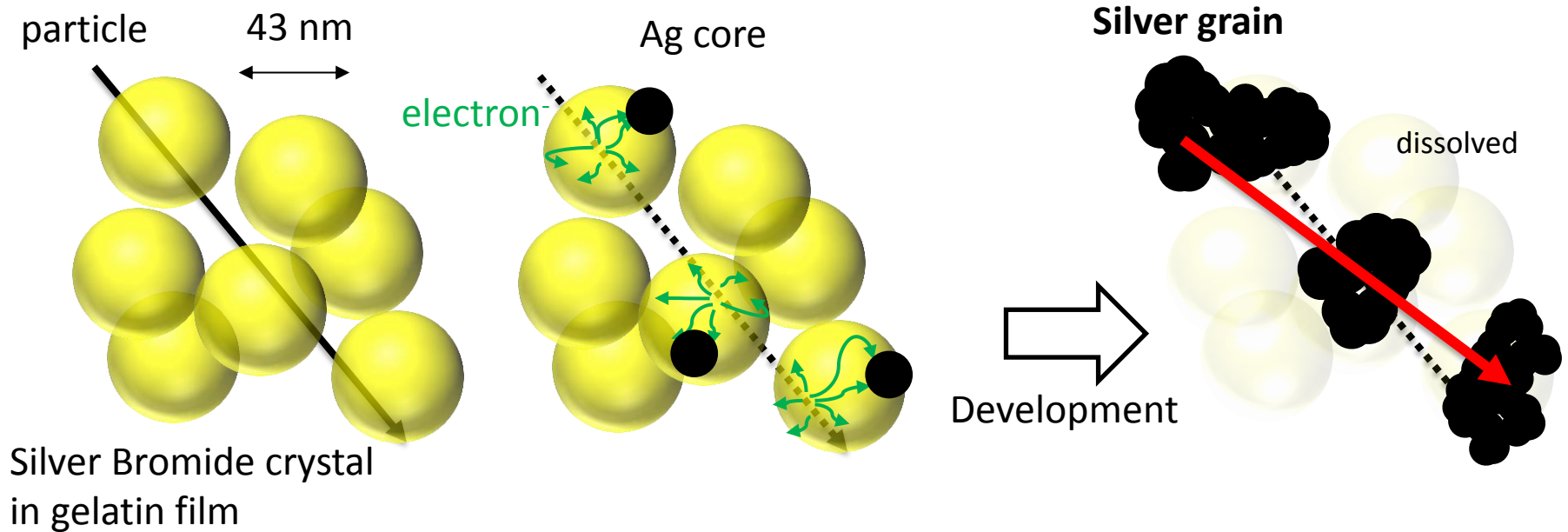


**This image is Not correct.  
More complicated  
information are included.**

**One silver grain is not just one grain !**

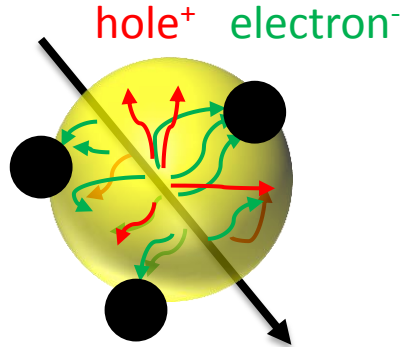


# Detection process of Emulsion

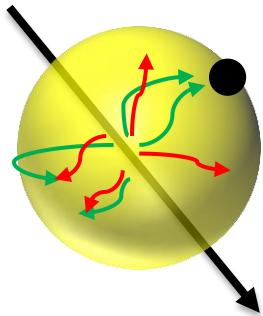


- ✓ number of latent image specks is not always one, high  $dE/dx$  particles form two or more latent image specks .
- ✓ developed grains have filament structure
- ✓ latent image speck size due to low  $dE/dx$  particles tend to small
- ✓ another nose is not filament structure

# Kind of events source



- Signal event (recoiled nuclei)
  - $de/dx$  : 100~1000 keV/ $\mu$ m
  - Cores become strong(big) and many

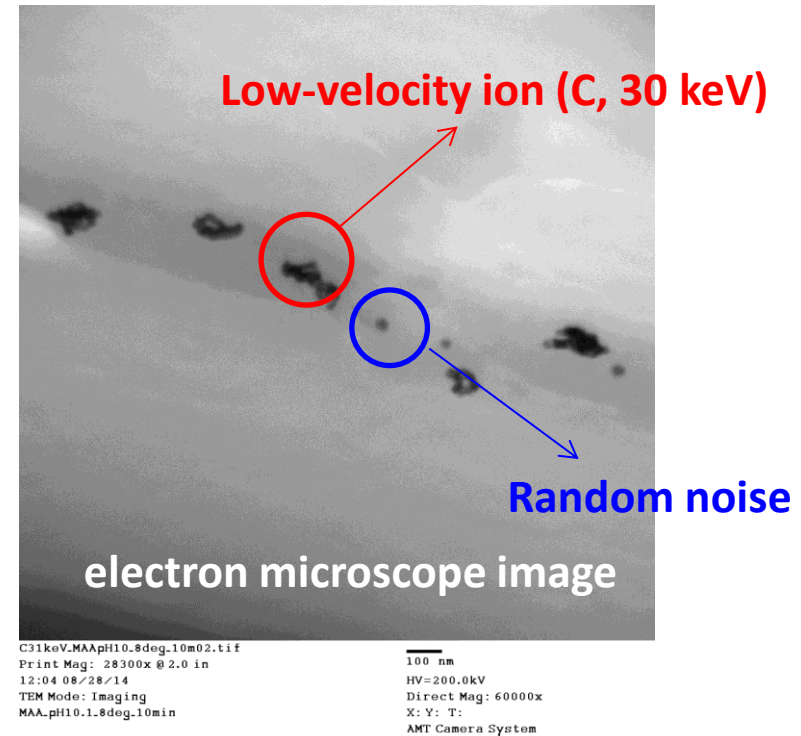
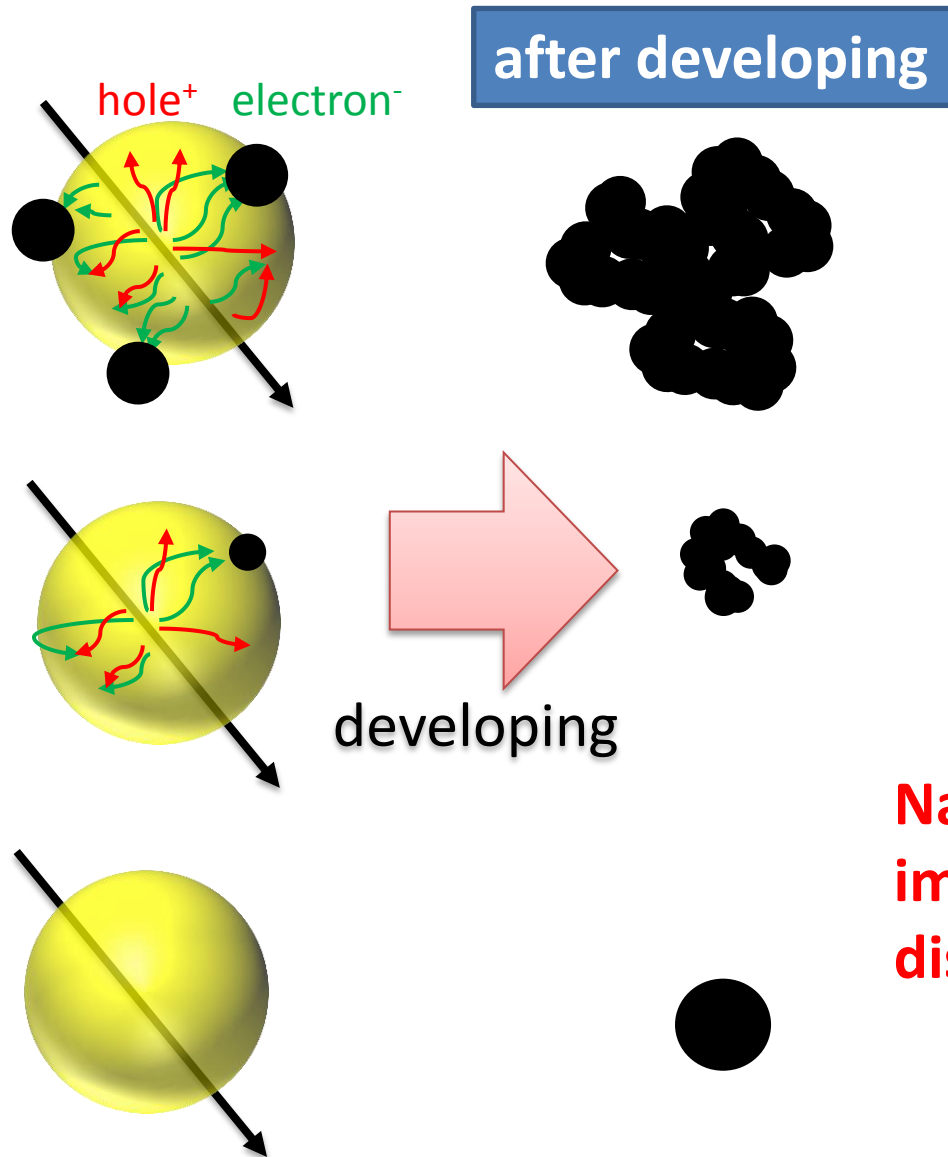


- Background event (electron)
  - $de/dx$  : 1~10 keV/ $\mu$ m
  - Cores become small and few



- Noise event (not from particle, unknown)
  - Core may be bigger than signal's one.

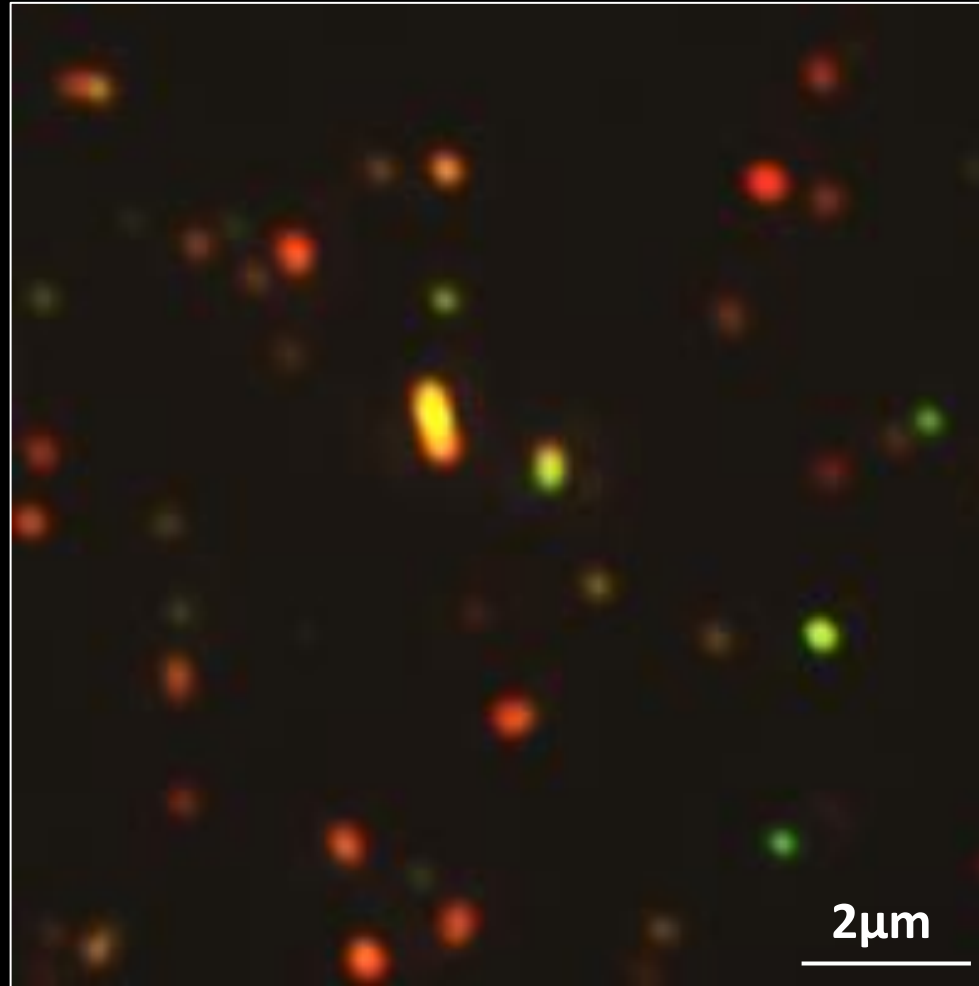
# Additional Information



**Nano-scale structure have very important information for distinguish of signal from noise**

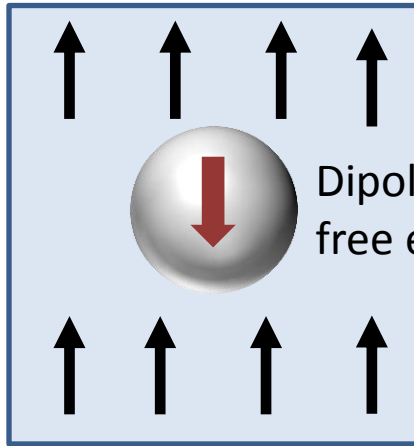
# Plasmon resonance in emulsion

Using optical microscope , can see tracks are colorful!!



Carbon ion track after developing process  
Taken by color camera (Halogen lamp  $\lambda = 300 \sim 3000 \text{ nm}$ )

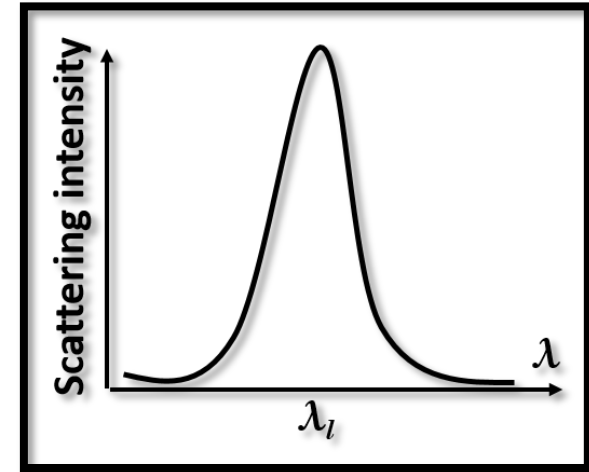
# Plasmon resonance in nano-metallic particle



$$p = 4\pi\epsilon_m a^3 \frac{\epsilon_1(\lambda) - \epsilon_m(\lambda)}{\epsilon_1(\lambda) + 2\epsilon_m(\lambda)} E_0$$

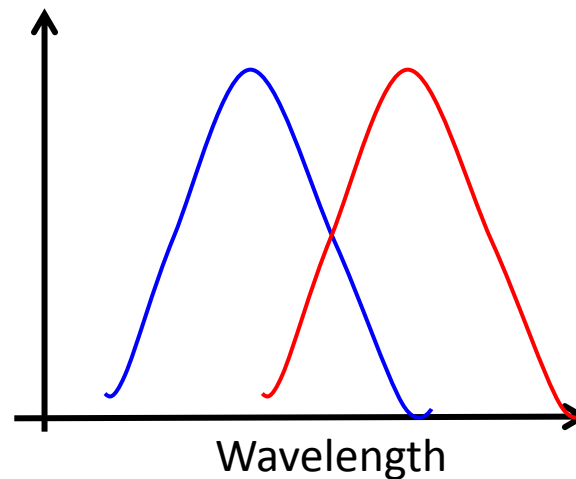
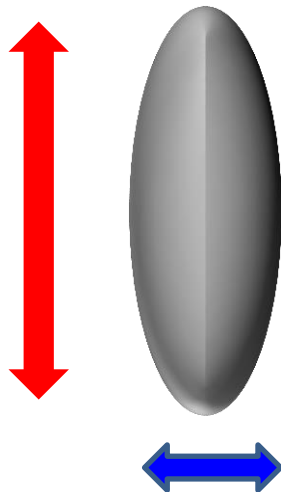
Dipole moment  $p$  for free electrons

$$\epsilon_1(\lambda_l) + 2\epsilon_m(\lambda_l) \approx 0$$



$\lambda_l$  has visible wave length for 40 – 100 nm Ag nano particle

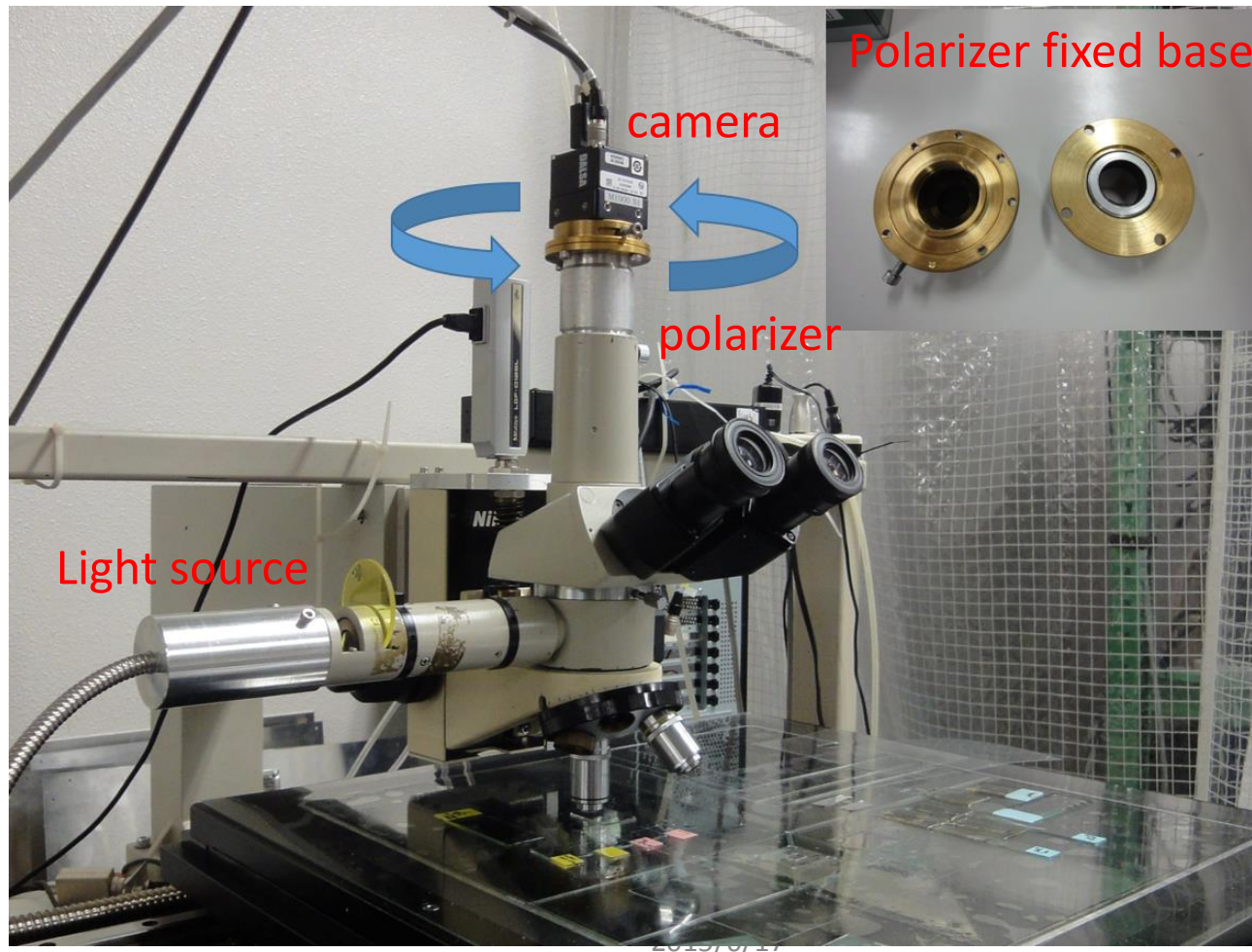
Polarized dependence





# Polarization analysis

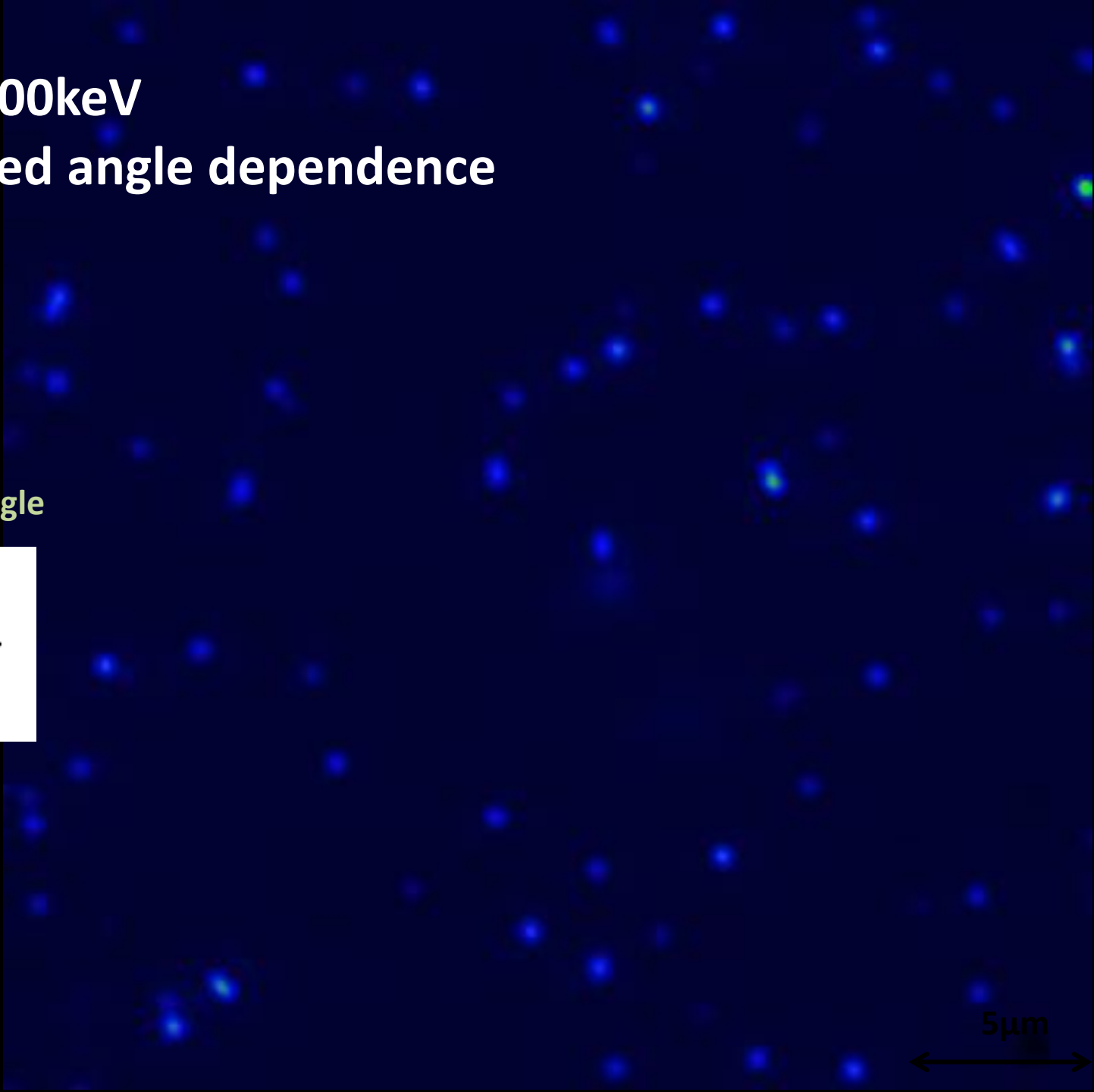
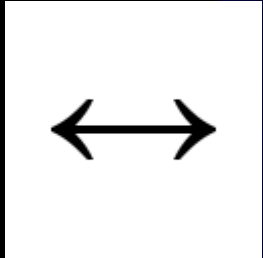
- develop the optical microscope that can do polarization analysis
- set a polarizer under the camera and rotate it



# C ion 100keV

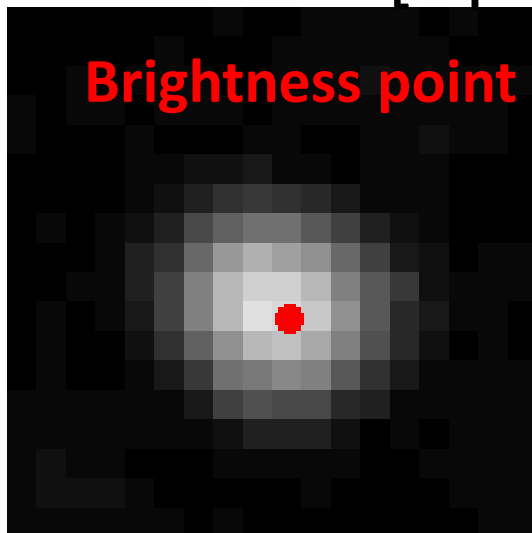
## Polarized angle dependence

Polarizer angle

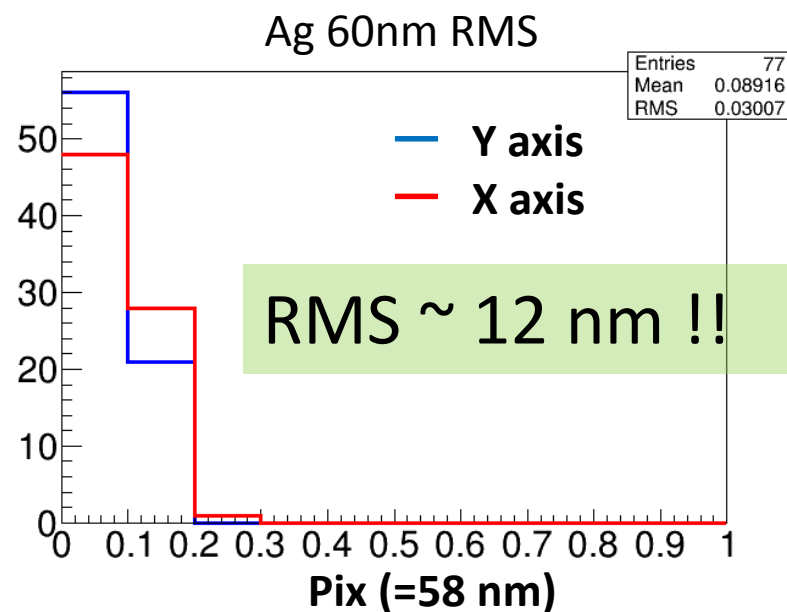
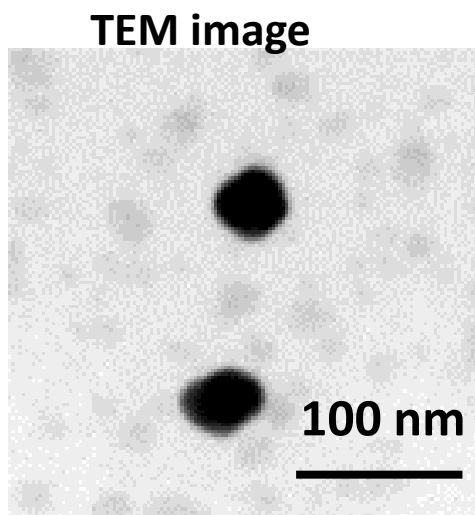
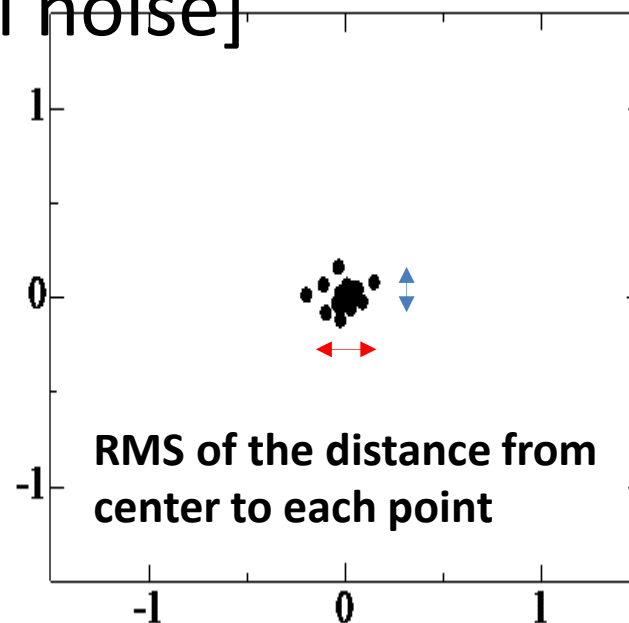


5 μm

# Super-high resolution technology [ spherical noise]

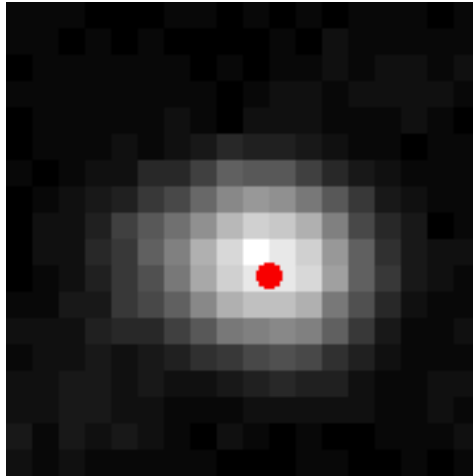


Ag cluster

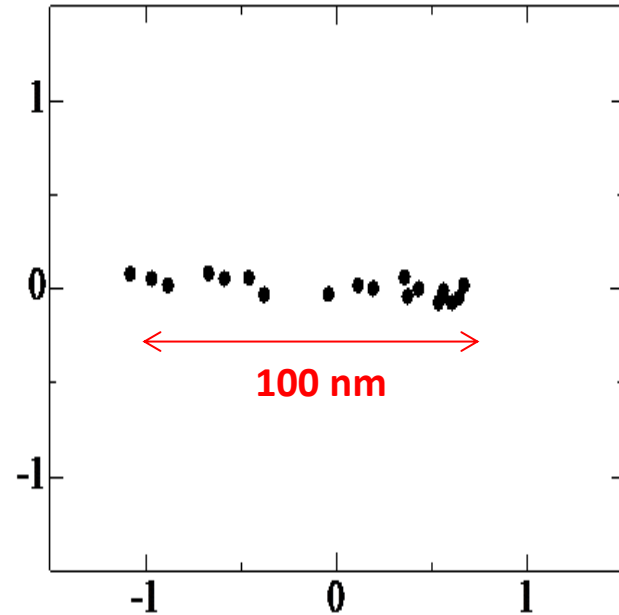


# Super-high resolution technology [ tracking ]

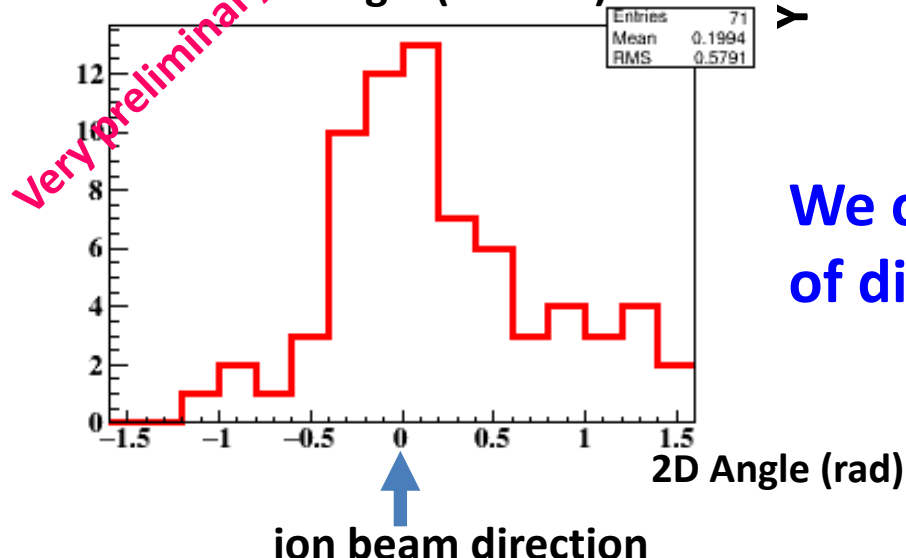
Track candidate



Y axis (pixel = 58nm)



Track angle (Elli<1.5)



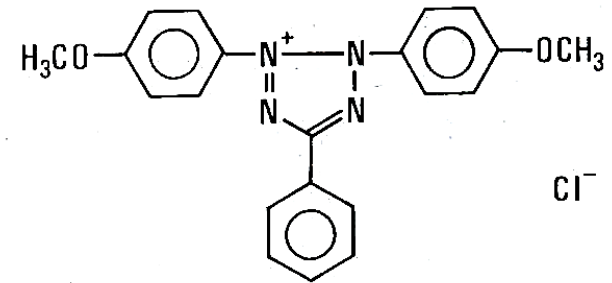
**We could obtain the information  
of direction except shape analysis!**

# Background rejection

## ❑ Chemical control of quantum efficiency of AgBr crystal

- ✓ electron trap on the crystal
  - ⇒ clearly separation between low  $dE/dx$  ( $\gamma$ · $\beta$ -rays) and high  $dE/dx$  (nuclear recoil)
- ✓ development speed dependent on latent image speck size
  - ⇒ separation as contrast or plasmon response

better than  $1E-6$  rejection power should be expected, at least from current study



2,3-di(methoxyphenyl)-5-phenyltetrazolium

## ❑ Cryogenic device

- ✓ utilize the temperature increase dependence between low- $dE/dx$  and high  $dE/dx$  particle in low-temperature device
  - ⇒ now on studing

**Background rejection power and more realist achievable sensitivity will be shown in this year.**



# Summary

- ❑ **Nano Imaging Tracker (NIT) was developed in Nagoya University**
  - crystal size : 40 nm ( $3.3 \text{ g/cm}^3$ )
- ❑ **Potential for NIT simulation with crystal effect**
  - it has direction sensitivity for more than 10 keV
  - angular resolution is better than 600 mrad. for more than 10 keV
- ❑ **Optical microscope system + X-ray microscope analysis @ SPring-8 are already running**
- ❑ **Low-velocity ion analysis using ion-implant system and optical microscopy**
  - improved to 65 % + 350 mrad. resolution by high resolution pixel analysis @ 60 keV C signal
  - Finally, about 70 % and 350 mrad ang. resolution is expected in dark matter search situation
  - Analysis data is consistent with simulation assume 100 % Q.E. of crystal

**Lower energy performance study is now on going .**

## Background study

- Plasmon analysis was achieved 10 nm resolution analysis
    - shorter length event analysis, signal and noise discrimination
  - Quantum efficiency control studies are on going
    - tetrazorium compound ; expected better than  $10^{-6}$  rejection power
    - cryogenic device ; also better than  $10^{-6}$  rejection power
  - replace the gelatin to petroleum-derived polymer (e.g., PVA, PVP, btadien etc)
- } **Finally combined**